

# FCC PART 15.247

## TEST REPORT

For

### **Xiamen VBeT Electronic Co.,Ltd.**

N403, Weiye Building, Xiamen Pioneering Park for Overseas Chinese Scholars, PRC

**FCC ID: 2AC67-VT9500BT**

<b>Report Type:</b> Original Report	<b>Product Type:</b> VT9500 Bluetooth Headset
<b>Test Engineer:</b> Leon Chen	<i>leon chen</i>
<b>Report Number:</b> RXM140820052-00A	
<b>Report Date:</b> 2014-09-03	
<b>Reviewed By:</b> Jerry Zhang EMC Manager	<i>Jerry Zhang</i>
<b>Test Laboratory:</b>	Bay Area Compliance Laboratories Corp. (Dongguan) No.69 Pulongcun, Puxinhu Industrial Zone, Tangxia, Dongguan, Guangdong, China Tel: +86-769-86858888 Fax: +86-769-86858891 <a href="http://www.baclcorp.com.cn">www.baclcorp.com.cn</a>

**Note:** This test report is prepared for the customer shown above and for the device described herein. It may not be duplicated or used in part without prior written consent from Bay Area Compliance Laboratories Corp. (Dongguan). This report is valid only with a valid digital signature. The digital signature may be available only under the Adobe software above version 7.0.

## TABLE OF CONTENTS

<b>GENERAL INFORMATION.....</b>	<b>4</b>
PRODUCT DESCRIPTION FOR EQUIPMENT UNDER TEST (EUT).....	4
OBJECTIVE.....	4
RELATED SUBMITTAL(S)/GRANT(S).....	4
TEST METHODOLOGY.....	4
TEST FACILITY.....	4
<b>SYSTEM TEST CONFIGURATION.....</b>	<b>5</b>
DESCRIPTION OF TEST CONFIGURATION.....	5
EUT EXERCISE SOFTWARE.....	5
EQUIPMENT MODIFICATIONS.....	5
SUPPORT EQUIPMENT LIST AND DETAILS.....	5
EXTERNAL I/O CABLE.....	5
BLOCK DIAGRAM OF TEST SETUP.....	6
<b>SUMMARY OF TEST RESULTS.....</b>	<b>7</b>
<b>FCC §15.247 (i) &amp; §1.1310 &amp; §2.1093- RF EXPOSURE.....</b>	<b>8</b>
APPLICABLE STANDARD.....	8
<b>FCC §15.203 - ANTENNA REQUIREMENT.....</b>	<b>9</b>
APPLICABLE STANDARD.....	9
ANTENNA CONNECTOR CONSTRUCTION.....	9
<b>FCC §15.207 – AC LINE CONDUCTED EMISSIONS.....</b>	<b>10</b>
MEASUREMENT UNCERTAINTY.....	10
EUT SETUP.....	10
EMI TEST RECEIVER SETUP.....	11
TEST PROCEDURE.....	11
CORRECTED AMPLITUDE & MARGIN CALCULATION.....	11
TEST EQUIPMENT LIST AND DETAILS.....	12
TEST RESULTS SUMMARY.....	12
TEST DATA.....	12
<b>FCC §15.209, §15.205 &amp; §15.247(d) - SPURIOUS EMISSIONS.....</b>	<b>15</b>
APPLICABLE STANDARD.....	15
MEASUREMENT UNCERTAINTY.....	15
EUT SETUP.....	15
EMI TEST RECEIVER & SPECTRUM ANALYZER SETUP.....	16
TEST PROCEDURE.....	16
TEST EQUIPMENT LIST AND DETAILS.....	17
CORRECTED AMPLITUDE & MARGIN CALCULATION.....	17
TEST RESULTS SUMMARY.....	17
TEST DATA.....	17
<b>FCC §15.247(a) (1) - CHANNEL SEPARATION TEST.....</b>	<b>19</b>
APPLICABLE STANDARD.....	19
TEST EQUIPMENT LIST AND DETAILS.....	19
TEST PROCEDURE.....	19
TEST DATA.....	19
<b>FCC §15.247(a) (1) – 20 dB BANDWIDTH TESTING.....</b>	<b>25</b>

APPLICABLE STANDARD .....25  
 TEST PROCEDURE .....25  
 TEST EQUIPMENT LIST AND DETAILS.....25  
 TEST DATA .....25

**FCC §15.247(a) (1) (iii) - QUANTITY OF HOPPING CHANNEL TEST .....31**  
 APPLICABLE STANDARD .....31  
 TEST PROCEDURE .....31  
 TEST EQUIPMENT LIST AND DETAILS.....31  
 TEST DATA .....31

**FCC §15.247(a) (1) (iii) - TIME OF OCCUPANCY (DWELL TIME).....35**  
 APPLICABLE STANDARD .....35  
 TEST PROCEDURE .....35  
 TEST EQUIPMENT LIST AND DETAILS.....35  
 TEST DATA .....35

**FCC §15.247(b) (1) - PEAK OUTPUT POWER MEASUREMENT .....51**  
 APPLICABLE STANDARD .....51  
 TEST PROCEDURE .....51  
 TEST EQUIPMENT LIST AND DETAILS.....51  
 TEST DATA .....51

**FCC §15.247(d) - BAND EDGES TESTING .....57**  
 APPLICABLE STANDARD .....57  
 TEST PROCEDURE .....57  
 TEST EQUIPMENT LIST AND DETAILS.....57  
 TEST DATA .....57

## GENERAL INFORMATION

---

### Product Description for Equipment under Test (EUT)

The *Xiamen VBeT Electronic Co.,Ltd.*'s product, model number: *VT9500 BT(FCC ID: 2AC67-VT9500BT)* (the "EUT") in this report was a *VT9500 Bluetooth Headset*, which was measured approximately: 15.4 cm (L) x5.2 cm (W) x17.1cm (H), rated input voltage: DC 3.7V from rechargeable Li-ion battery or DC5V charging from charger base.

Adapter Information: GME  
Model: GME031U-050050  
I/P: AC100-240V, 50-60Hz, 0.15A  
O/P: DC 5V, 0.5A

*All measurement and test data in this report was gathered from production sample serial number: 140820052. (Assigned by BACL, Dongguan). The EUT was received on 2014-08-22.*

### Objective

This report is prepared on behalf of *Xiamen VBeT Electronic Co.,Ltd.* in accordance with Part 2, Subpart J, Part 15, Subparts A, B and C of the Federal Communications Commission's rules

The tests were performed in order to determine the Bluetooth BDR and EDR mode of EUT compliance with FCC Part 15, Subpart C, and section 15.203, 15.205, 15.207, 15.209 and 15.247 rules.

### Related Submittal(s)/Grant(s)

No Related Submittal.

### Test Methodology

All measurements contained in this report were conducted with ANSI C63.4-2003, American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the range of 9 kHz to 40 GHz.

All emissions measurement was performed and Bay Area Compliance Laboratories Corp. (Dongguan).

### Test Facility

The Test site used by Bay Area Compliance Laboratories Corp. (Dongguan) to collect test data is located on the No.69 Pulongcun, Puxinhu Industrial Zone, Tangxia, Dongguan, Guangdong, China

Test site at Bay Area Compliance Laboratories Corp. (Dongguan) has been fully described in reports submitted to the Federal Communications Commission (FCC). The details of these reports have been found to be in compliance with the requirements of Section 2.948 of the FCC Rules on February 02, 2012. The facility also complies with the radiated and AC line conducted test site criteria set forth in ANSI C63.4-2003.

The Federal Communications Commission has the reports on file and is listed under FCC Registration No.: 273710. The test site has been approved by the FCC for public use and is listed in the FCC Public Access Link (PAL) database.

## SYSTEM TEST CONFIGURATION

### Description of Test Configuration

The system was configured for testing in an engineering mode.

### EUT Exercise Software

The software “CSR Bluesuite 2.5.0” was used, which was provided by manufacturer. The maximum power was set by default configuration.

Test Software Version		CSR Bluesuite 2.5.0		
Test Frequency		2402MHz	2441MHz	2480MHz
Power Level Setting	GFSK	63	63	63
	$\pi/4$ DQPSK	100	100	100
	8DPSK	100	100	100

### Equipment Modifications

No modification was made to the EUT.

### Support Equipment List and Details

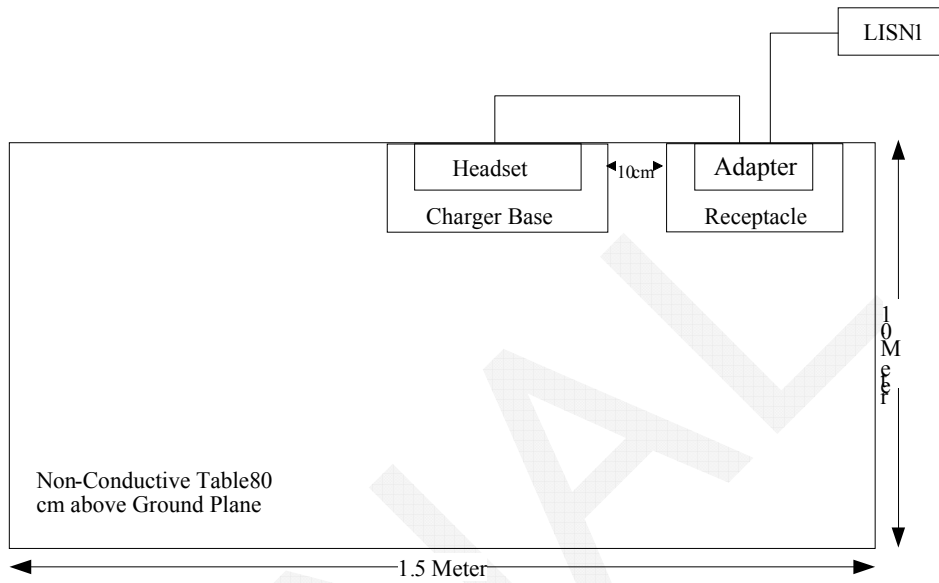
Manufacturer	Description	Model	Serial Number
/	/	/	/

### External I/O Cable

Cable Description	Shielding Type	Ferrite Core	Length (m)	From Port	To
Adapter Cable	no	no	1.8	Adapter	Charger Base

### Block Diagram of Test Setup

For Conducted Emission Test:



**SUMMARY OF TEST RESULTS**

FCC Rules	Description of Test	Result
FCC §15.247 (i) & §1.1310 & §2.1093	RF Exposure	Compliance
§15.203	Antenna Requirement	Compliance
§15.207 (a)	Conducted Emissions	Compliance
§15.205, §15.209, §15.247(d)	Radiated Emissions	Compliance
§15.247 (a)(1)	20 dB Bandwidth	Compliance
§15.247(a)(1)	Channel Separation Test	Compliance
§15.247(a)(1)(iii)	Time of Occupancy (Dwell Time)	Compliance
§15.247(a)(1)(iii)	Quantity of hopping channel Test	Compliance
§15.247(b)(1)	Peak Output Power Measurement	Compliance
§15.247(d)	Band Edges	Compliance

## **FCC §15.247 (i) & §1.1310 & §2.1093- RF EXPOSURE**

### **Applicable Standard**

According to §15.247(i) and §1.1310, systems operating under the provisions of this section shall be operated in a manner that ensure that the public is not exposed to radio frequency energy level in excess of the Commission's guideline.

According to KDB447498 D01 General RF Exposure Guidance v05r02:

The 1-g and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances  $\leq 50$  mm are determined by:

$[(\text{max. power of channel, including tune-up tolerance, mW})/(\text{min. test separation distance, mm})] \cdot [\sqrt{f(\text{GHz})}] \leq 3.0$  for 1-g SAR and  $\leq 7.5$  for 10-g extremity SAR, where

- $f(\text{GHz})$  is the RF channel transmit frequency in GHz
- Power and distance are rounded to the nearest mW and mm before calculation
- The result is rounded to one decimal place for comparison
- 3.0 and 7.5 are referred to as the numeric thresholds in the step 2 below

The test exclusions are applicable only when the minimum test separation distance is  $\leq 50$  mm and for transmission frequencies between 100 MHz and 6 GHz. When the minimum test separation distance is  $< 5$  mm, a distance of 5 mm according to 5) in section 4.1 is applied to determine SAR test exclusion.

### **Measurement Result**

The maximum conducted output power= 2.68 dBm (1.85 mW) at 2480 MHz  
 $[(\text{max. power of channel, mW})/(\text{min. test separation distance, mm})] \cdot [\sqrt{f(\text{GHz})}]$   
 $= 1.85/5 \cdot (\sqrt{2.480}) = 0.583 < 3.0$

**So the stand-alone SAR evaluation is not necessary.**



---

## **FCC §15.203 - ANTENNA REQUIREMENT**

---

### **Applicable Standard**

According to FCC § 15.203, an intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator shall be considered sufficient to comply with the provisions of this Section. The manufacturer may design the unit so that a broken antenna can be replaced by the user, but the use of a standard antenna jack or electrical connector is prohibited.

### **Antenna Connector Construction**

The EUT has one integral antenna arrangement, which was permanently attached and the antenna gain is 2.0 dBi, fulfill the requirement of this section. Please refer to the EUT photos.

**Result:** Compliant.

## FCC §15.207 – AC LINE CONDUCTED EMISSIONS

### Measurement Uncertainty

Compliance or non-compliance with a disturbance limit shall be determined in the following manner:

If  $U_{lab}$  is less than or equal to  $U_{cispr}$  of Table 1, then:

- compliance is deemed to occur if no measured disturbance level exceeds the disturbance limit;
- non-compliance is deemed to occur if any measured disturbance level exceeds the disturbance limit.

If  $U_{lab}$  is greater than  $U_{cispr}$  of Table 1, then:

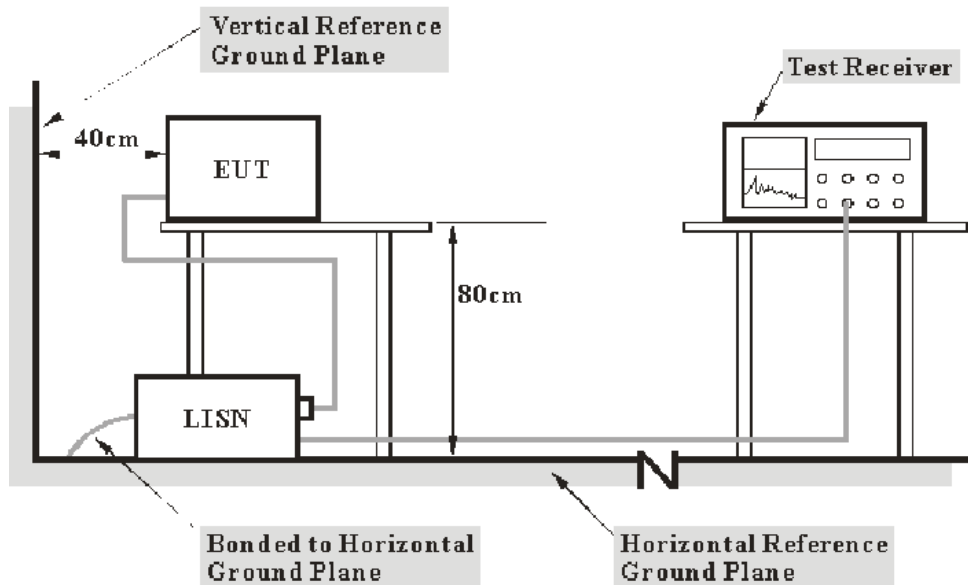
- compliance is deemed to occur if no measured disturbance level, increased by  $(U_{lab} - U_{cispr})$ , exceeds the disturbance limit;
- non-compliance is deemed to occur if any measured disturbance level, increased by  $(U_{lab} - U_{cispr})$ , exceeds the disturbance limit.

Based on CISPR 16-4-2: 2011, measurement uncertainty of conducted disturbance at mains port using AMN at Bay Area Compliance Laboratories Corp. (Dongguan) is 3.46 dB (150 kHz to 30 MHz).

Table 1 – Values of  $U_{cispr}$

Measurement	$U_{cispr}$
Conducted disturbance at mains port using AMN (150 kHz to 30 MHz)	3.4 dB

### EUT Setup



- Note: 1. Support units were connected to second LISN.  
 2. Both of LISNs (AMN) 80 cm from EUT and at least 80 cm from other units and other metal planes support units.

The setup of EUT is according with per ANSI C63.4-2003 measurement procedure. The specification used was with the FCC Part 15.207 Class B limits.

The spacing between the peripherals was 10 cm.

The adapter was connected to a 120 VAC/60 Hz power source

### EMI Test Receiver Setup

The EMI test receiver was set to investigate the spectrum from 150 kHz to 30 MHz.

During the conducted emission test, the EMI test receiver was set with the following configurations:

Frequency Range	IF B/W
150 kHz – 30 MHz	9 kHz

### Test Procedure

During the conducted emission test, the adapter was connected to the outlet of the first LISN and the other support equipments were connected to the outlet of the second LISN.

Maximizing procedure was performed on the six (6) highest emissions of the EUT.

All data was recorded in the Quasi-peak and average detection mode.

### Corrected Amplitude & Margin Calculation

The basic equation is as follows:

$$V_C = V_R + A_C + VDF$$

$$C_f = A_C + VDF$$

Herein,

$V_C$  (cord. Reading): corrected voltage amplitude

$V_R$ : reading voltage amplitude

$A_C$ : attenuation caused by cable loss

$VDF$ : voltage division factor of AMN

$C_f$ : Correction Factor

The “**Margin**” column of the following data tables indicates the degree of compliance within the applicable limit. For example, a margin of 7dB means the emission is 7dB below the maximum limit. The equation for margin calculation is as follows:

$$\text{Margin} = \text{Limit} - \text{Corrected Amplitude}$$

### Test Equipment List and Details

Manufacturer	Description	Model	Serial Number	Calibration Date	Calibration Due Date
R&S	EMI Test Receiver	ESCS 30	830245/006	2013-11-20	2014-11-20
R&S	L.I.S.N	ESH3-Z5	843331/015	2013-09-25	2014-09-25
R&S	Two-line V-network	ENV 216	3560.6550.12	2014-01-22	2015-01-22
R&S	Test Software	EMC32	Version8.53.0	N/A	N/A

\* **Statement of Traceability:** Bay Area Compliance Laboratories Corp. (Dongguan) attests that all calibrations have been performed, traceable to National Primary Standards and International System of Units (SI).

### Test Results Summary

According to the recorded data in following table, the EUT complied with the FCC Part 15.207, with the worst margin reading of:

**28.9 dB at 1.599078 MHz in the Neutral conducted mode**

### Test Data

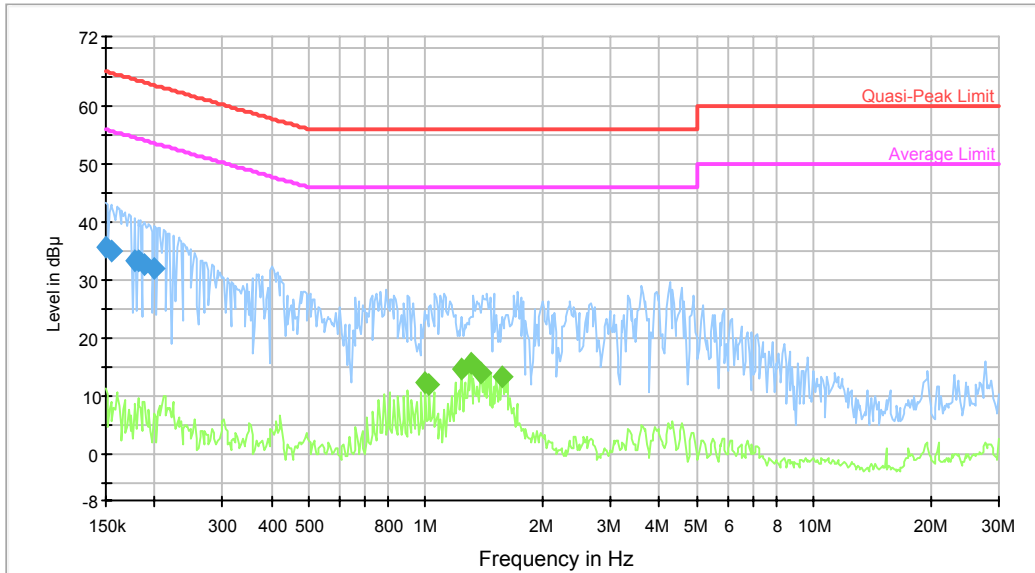
#### Environmental Conditions

<b>Temperature:</b>	30.4 °C
<b>Relative Humidity:</b>	60%
<b>ATM Pressure:</b>	100.5 kPa

*The testing was performed by Leon Chen on 2014-08-26.*

Test mode: Charging&transmitting

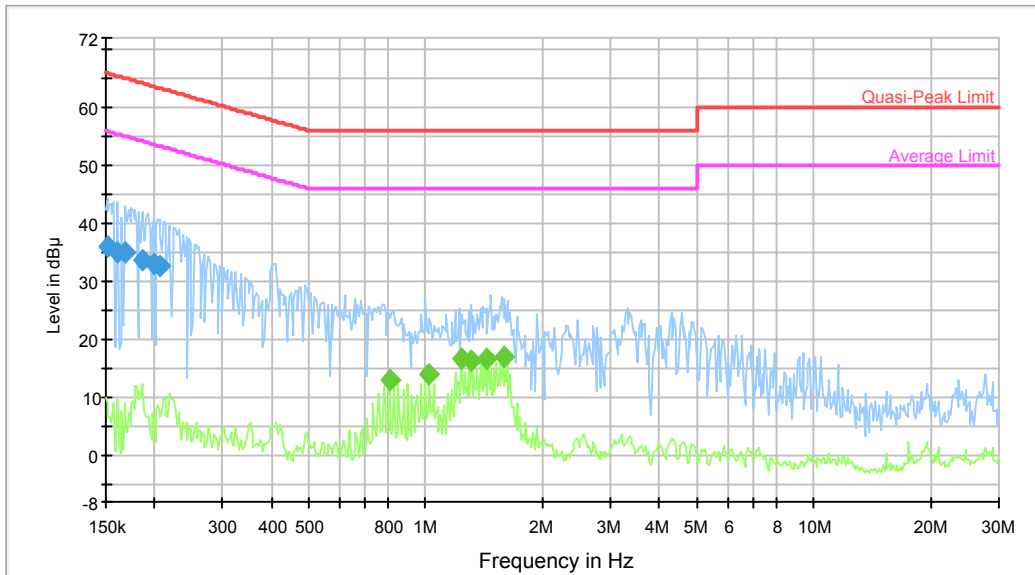
AC120 V, 60 Hz, Line:



Frequency (MHz)	QuasiPeak (dBµV)	Bandwidth (kHz)	Line	Corr. (dB)	Margin (dB)	Limit (dBµV)	Comment
0.150000	35.6	9.000	L1	10.0	30.4	66.0	Compliance
0.156097	35.0	9.000	L1	10.1	30.7	65.7	Compliance
0.178741	33.4	9.000	L1	10.4	31.2	64.5	Compliance
0.181612	33.2	9.000	L1	10.5	31.2	64.4	Compliance
0.188994	32.8	9.000	L1	10.6	31.3	64.1	Compliance
0.199835	32.1	9.000	L1	10.8	31.6	63.6	Compliance

Frequency (MHz)	Average (dBµV)	Bandwidth (kHz)	Line	Corr. (dB)	Margin (dB)	Limit (dBµV)	Comment
0.999305	12.3	9.000	L1	10.4	33.7	46.0	Compliance
1.023481	12.0	9.000	L1	10.4	34.0	46.0	Compliance
1.239175	14.6	9.000	L1	10.4	31.4	46.0	Compliance
1.310256	15.6	9.000	L1	10.4	30.4	46.0	Compliance
1.385415	14.1	9.000	L1	10.4	31.9	46.0	Compliance
1.573796	13.5	9.000	L1	10.4	32.5	46.0	Compliance

**AC120 V, 60 Hz, Neutral:**



Frequency (MHz)	QuasiPeak (dBµV)	Bandwidth (kHz)	Line	Corr. (dB)	Margin (dB)	Limit (dBµV)	Comment
0.151200	35.9	9.000	N	10.3	30.0	65.9	Compliance
0.161152	35.2	9.000	N	10.5	30.2	65.4	Compliance
0.167702	35.0	9.000	N	10.6	30.1	65.1	Compliance
0.187494	33.7	9.000	N	11.1	30.4	64.1	Compliance
0.199835	33.1	9.000	N	11.4	30.6	63.6	Compliance
0.206306	32.6	9.000	N	11.3	30.8	63.4	Compliance

Frequency (MHz)	Average (dBµV)	Bandwidth (kHz)	Line	Corr. (dB)	Margin (dB)	Limit (dBµV)	Comment
0.805868	12.9	9.000	N	10.5	33.1	46.0	Compliance
1.023481	13.9	9.000	N	10.5	32.1	46.0	Compliance
1.239175	16.5	9.000	N	10.5	29.5	46.0	Compliance
1.310256	16.2	9.000	N	10.5	29.8	46.0	Compliance
1.430284	16.7	9.000	N	10.5	29.3	46.0	Compliance
1.599078	17.1	9.000	N	10.5	28.9	46.0	Compliance

**FCC §15.209, §15.205 & §15.247(d) - SPURIOUS EMISSIONS**

**Applicable Standard**

FCC §15.247 (d); §15.209; §15.205;

**Measurement Uncertainty**

Compliance or non-compliance with a disturbance limit shall be determined in the following manner:

If  $U_{lab}$  is less than or equal to  $U_{cispr}$  of Table 1, then:

- compliance is deemed to occur if no measured disturbance level exceeds the disturbance limit;
- non-compliance is deemed to occur if any measured disturbance level exceeds the disturbance limit.

If  $U_{lab}$  is greater than  $U_{cispr}$  of Table 1, then:

- compliance is deemed to occur if no measured disturbance level, increased by  $(U_{lab} - U_{cispr})$ , exceeds the disturbance limit;
- non-compliance is deemed to occur if any measured disturbance level, increased by  $(U_{lab} - U_{cispr})$ , exceeds the disturbance limit.

Based on CISPR 16-4-2: 2011, measurement uncertainty of radiated emission at a distance of 3m at Bay Area Compliance Laboratories Corp. (Dongguan) is:

30M~200MHz: 5.0 dB

200M~1GHz: 6.2 dB

1G~6GHz: 4.45 dB

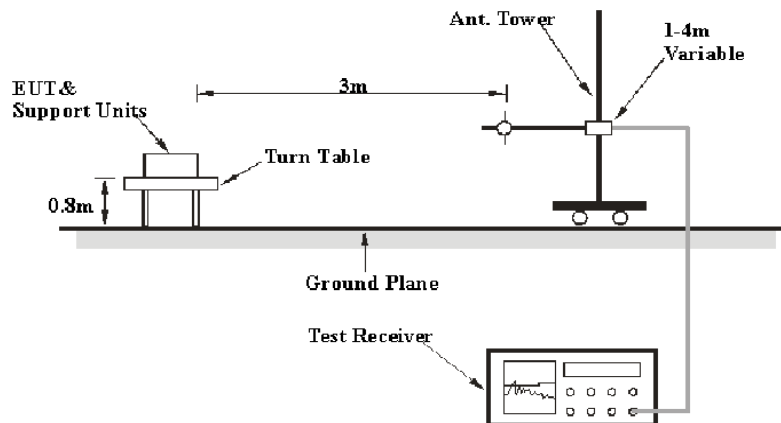
6G~18GHz: 5.23 dB

Table 1 – Values of  $U_{cispr}$

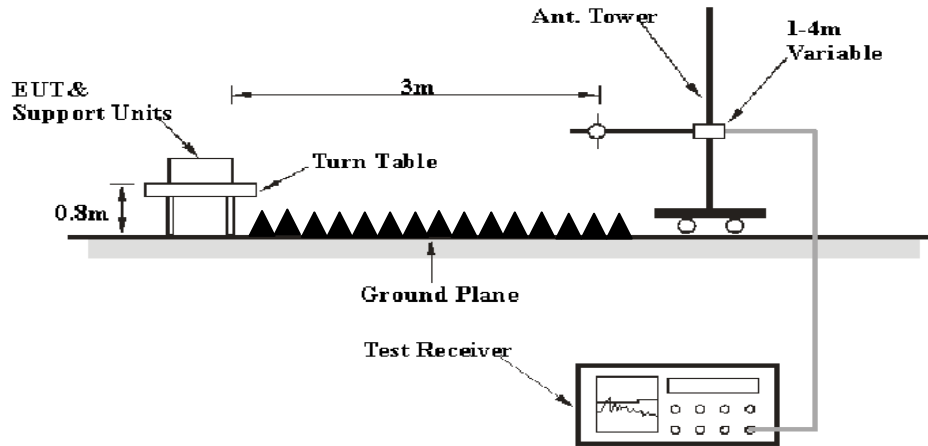
Measurement	$U_{cispr}$
Radiated disturbance (electric field strength at an OATS or in a SAC) (30 MHz to 1000 MHz)	6.3 dB
Radiated disturbance (electric field strength in a FAR) (1 GHz to 6 GHz)	5.2 dB
Radiated disturbance (electric field strength in a FAR) (6 GHz to 18 GHz)	5.5 dB

**EUT Setup**

**Below 1GHz:**



**Above 1GHz:**



The radiated emission tests were performed in the 3 meters test site, using the setup accordance with the ANSI C63.4-2003. The specification used was the FCC 15.209, and FCC 15.247 limits.

The external I/O cables were draped along the test table and formed a bundle 30 to 40 cm long in the middle.

The spacing between the peripherals was 10 cm.

**EMI Test Receiver & Spectrum Analyzer Setup**

The system was investigated from 30 MHz to 25 GHz.

During the radiated emission test, the EMI test receiver & Spectrum Analyzer Setup were set with the following configurations:

Frequency Range	RBW	Video B/W	IF B/W	Detector
30 MHz – 1000 MHz	120 kHz	300 kHz	120 kHz	QP
Above 1 GHz	1MHz	3 MHz	/	PK
	1MHz	10 Hz	/	Ave.

**Test Procedure**

Maximizing procedure was performed on the highest emissions to ensure that the EUT complied with all installation combinations.

Data was recorded in Quasi-peak detection mode for frequency range of 30 MHz - 1 GHz, peak and average detection modes for frequencies above 1 GHz.



### Test Equipment List and Details

Manufacturer	Description	Model	Serial Number	Calibration Date	Calibration Due Date
R&S	EMI Test Receiver	ESCI	100224	2014-05-09	2015-05-09
Sunol Sciences	Antenna	JB3	A060611-1	2011-09-06	2014-09-05
HP	Amplifier	8447E	2434A02181	2014-09-01	2015-09-01
R&S	Spectrum Analyzer	FSEM	DE31388	2014-05-09	2015-05-09
ETS-Lindgren	Horn Antenna	3115	000 527 35	2012-09-06	2015-09-06
Mini-Circuit	Amplifier	ZVA-213-S+	054201245	2014-02-19	2015-02-19
Ducommun Technologies	Horn Antenna	ARH-4223-02	1007726-01 1304	2014-06-16	2015-06-15

\* **Statement of Traceability:** Bay Area Compliance Laboratories Corp. (Dongguan) attests that all calibrations have been performed, traceable to National Primary Standards and International System of Units (SI).

### Corrected Amplitude & Margin Calculation

The Corrected Amplitude is calculated by adding the Antenna Factor and Cable Loss, and subtracting the Amplifier Gain from the Meter Reading. The basic equation is as follows:

$$\text{Corrected Amplitude} = \text{Meter Reading} + \text{Antenna Factor} + \text{Cable Loss} - \text{Amplifier Gain}$$

The “**Margin**” column of the following data tables indicates the degree of compliance with the applicable limit. For example, a margin of 7dB means the emission is 7dB below the limit. The equation for margin calculation is as follows:

$$\text{Margin} = \text{Limit} - \text{Corrected Amplitude}$$

### Test Results Summary

According to the recorded data in following table, the EUT complied with the FCC Title 47, Part 15, Subpart C, and section 15.205, 15.209 and 15.247, with the worst margin reading of:

**9.79dB at 2483.5 MHz in the Horizontal polarization**

### Test Data

#### Environmental Conditions

<b>Temperature:</b>	28.3 °C
<b>Relative Humidity:</b>	56%
<b>ATM Pressure:</b>	100.4 kPa

*The testing was performed by Leon Chen on 2014-09-01.*

*Mode: Transmitting*

30 MHz-25 GHz:

Scan with GFSK,  $\pi/4$ -DQPSK, 8DPSK mode, the worst case is GFSK mode.

Frequency (MHz)	Receiver		Rx Antenna		Cable loss (dB)	Amplifier Gain (dB)	Corrected Amplitude (dB $\mu$ V/m)	FCC 15.247	
	Reading (dB $\mu$ V)	Detector (PK/QP/AV)	Polar (H/V)	Factor (dB)				Limit (dB $\mu$ V/m)	Margin (dB)
Low Channel: 2402 MHz									
2402	62.32	PK	H	25.65	4.42	0.00	92.39	N/A	N/A
2402	52.61	AV	H	25.65	4.42	0.00	82.68	N/A	N/A
2402	54.31	PK	V	25.65	4.42	0.00	84.38	N/A	N/A
2402	44.06	AV	V	25.65	4.42	0.00	74.13	N/A	N/A
2390	25.67	PK	H	25.61	4.39	0.00	55.67	74.00	18.33
2390	13.43	AV	H	25.61	4.39	0.00	43.43	54.00	10.57
4804	40.57	PK	H	30.59	5.98	27.41	49.73	74.00	24.27
4804	21.64	AV	H	30.59	5.98	27.41	30.80	54.00	23.20
7206	31.29	PK	H	34.09	7.45	25.91	46.92	74.00	27.08
7206	19.36	AV	H	34.09	7.45	25.91	34.99	54.00	19.01
9608	28.27	PK	H	35.96	8.80	27.55	45.48	74.00	28.52
9608	16.79	AV	H	35.96	8.80	27.55	34.00	54.00	20.00
2005	35.76	PK	H	24.61	3.83	27.48	36.72	74.00	37.28
2005	23.66	AV	H	24.61	3.83	27.48	24.62	54.00	29.38
166.7	35.16	QP	H	12.25	1.55	21.44	27.52	43.50	15.98
Middle Channel: 2441 MHz									
2441	63.65	PK	H	25.75	4.40	0.00	93.80	N/A	N/A
2441	53.80	AV	H	25.75	4.40	0.00	83.95	N/A	N/A
2441	56.49	PK	V	25.75	4.40	0.00	86.64	N/A	N/A
2441	46.43	AV	V	25.75	4.40	0.00	76.58	N/A	N/A
4882	41.03	PK	H	30.79	6.08	27.42	50.48	74.00	23.52
4882	22.03	AV	H	30.79	6.08	27.42	31.48	54.00	22.52
7323	31.96	PK	H	34.38	7.51	25.88	47.97	74.00	26.03
7323	19.88	AV	H	34.38	7.51	25.88	35.89	54.00	18.11
9764	28.43	PK	H	36.33	8.83	27.20	46.39	74.00	27.61
9764	17.47	AV	H	36.33	8.83	27.20	35.43	54.00	18.57
2005	34.99	PK	H	24.61	3.83	27.48	35.95	74.00	38.05
2005	23.18	AV	H	24.61	3.83	27.48	24.14	54.00	29.86
7336	32.06	PK	H	34.41	7.52	25.88	48.11	74.00	25.89
7336	20.46	AV	H	34.41	7.52	25.88	36.51	54.00	17.49
166.7	35.29	QP	H	12.25	1.55	21.44	27.65	43.50	15.85
High Channel: 2480 MHz									
2480	64.18	PK	H	25.85	4.48	0.00	94.51	N/A	N/A
2480	54.11	AV	H	25.85	4.48	0.00	84.44	N/A	N/A
2480	58.30	PK	V	25.85	4.48	0.00	88.63	N/A	N/A
2480	47.97	AV	V	25.85	4.48	0.00	78.30	N/A	N/A
2483.5	25.99	PK	H	25.86	4.49	0.00	56.34	74.00	17.66
2483.5	13.86	AV	H	25.86	4.49	0.00	44.21	54.00	9.79
4960	43.26	PK	H	31.00	5.90	27.43	52.73	74.00	21.27
4960	23.30	AV	H	31.00	5.90	27.43	32.77	54.00	21.23
7440	31.60	PK	H	34.66	7.58	25.97	47.87	74.00	26.13
7440	18.97	AV	H	34.66	7.58	25.97	35.24	54.00	18.76
9920	27.85	PK	H	36.71	8.87	26.66	46.77	74.00	27.23
9920	15.34	AV	H	36.71	8.87	26.66	34.26	54.00	19.74
2005	34.66	PK	H	24.61	3.83	27.48	35.62	74.00	38.38
2005	21.49	AV	H	24.61	3.83	27.48	22.45	54.00	31.55
166.7	35.47	QP	H	12.25	1.55	21.44	27.83	43.50	15.67

## FCC §15.247(a) (1) - CHANNEL SEPARATION TEST

### Applicable Standard

Frequency hopping systems shall have hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20dB bandwidth of the hopping channel, whichever is greater. Alternatively, frequency hopping systems operating in the 2400-2483.50 MHz band may have hopping channel carrier frequencies that are separated by 25 kHz or two-thirds of the 20dB bandwidth of the hopping channel, whichever is greater provided the systems operate with an output power no greater than 125 mW.

### Test Equipment List and Details

Manufacturer	Description	Model	Serial Number	Calibration Date	Calibration Due Date
R&S	Spectrum Analyzer	FSP 38	100478	2014-05-09	2015-05-08

\* **Statement of Traceability:** Bay Area Compliance Laboratories Corp. (Dongguan) attests that all calibrations have been performed, traceable to National Primary Standards and International System of Units (SI).

### Test Procedure

1. Set the EUT in transmitting mode, spectrum Bandwidth was set at 30 kHz, maxhold the channel.
2. Set the adjacent channel of the EUT maxhold another trace
3. Measure the channel separation.

### Test Data

#### Environmental Conditions

<b>Temperature:</b>	30.1 °C
<b>Relative Humidity:</b>	60%
<b>ATM Pressure:</b>	100.8 kPa

*The testing was performed by Leon Chen on 2014-08-29.*

**Test Result:** Compliance.

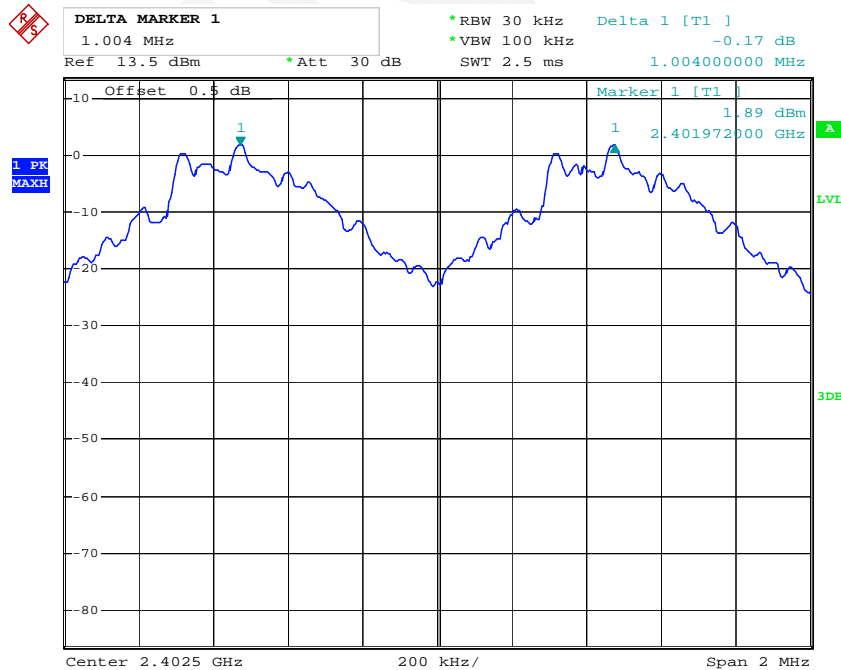
Please refer to following tables and plots

Test Mode: Transmitting

Mode	Channel	Frequency (MHz)	Channel Separation (MHz)	Limit (MHz)	Result
BDR Mode (GFSK)	Low	2402	1.004	0.571	Pass
	Adjacent	2403			
	Middle	2441	1.004	0.571	Pass
	Adjacent	2442			
	High	2480	1.004	0.571	Pass
	Adjacent	2479			
EDR Mode ( $\pi/4$ -DQPSK)	Low	2402	1.004	0.816	Pass
	Adjacent	2403			
	Middle	2441	1.004	0.816	Pass
	Adjacent	2442			
	High	2480	1.004	0.816	Pass
	Adjacent	2479			
EDR Mode (8DPSK)	Low	2402	1.004	0.811	Pass
	Adjacent	2403			
	Middle	2441	1.004	0.811	Pass
	Adjacent	2442			
	High	2480	1.004	0.811	Pass
	Adjacent	2479			

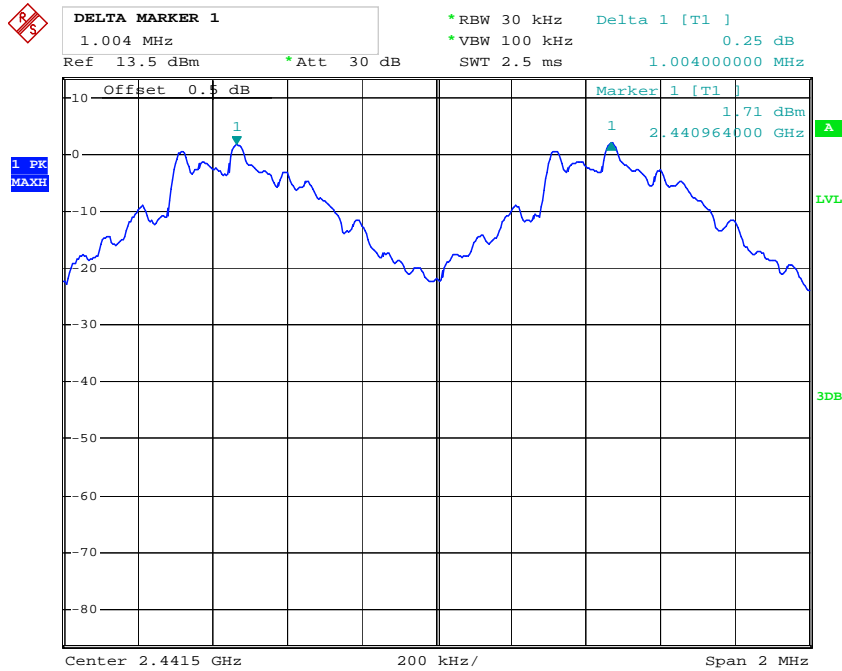
BDR Mode (GFSK):

Low Channel



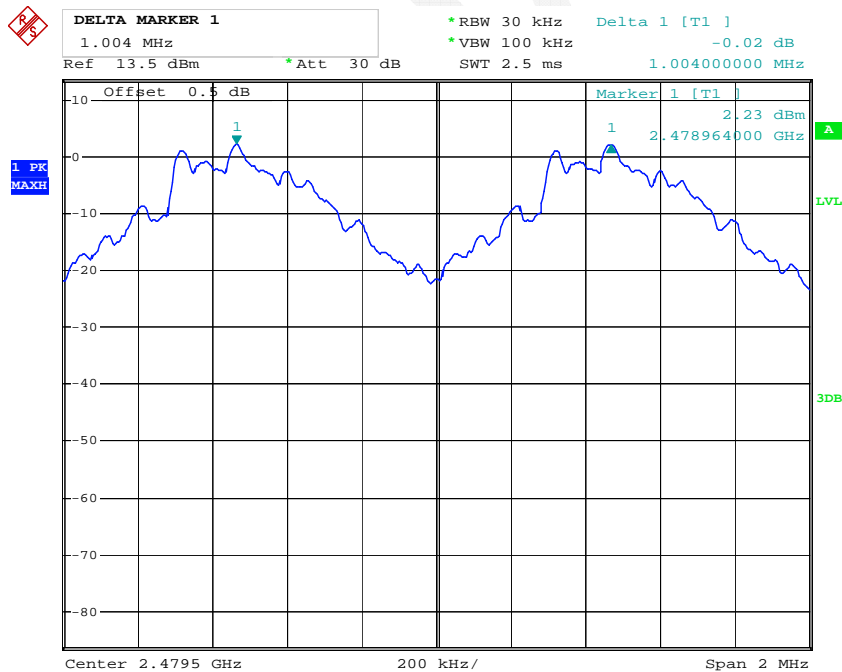
Date: 29.AUG.2014 18:06:48

### Middle Channel



Date: 29.AUG.2014 17:57:50

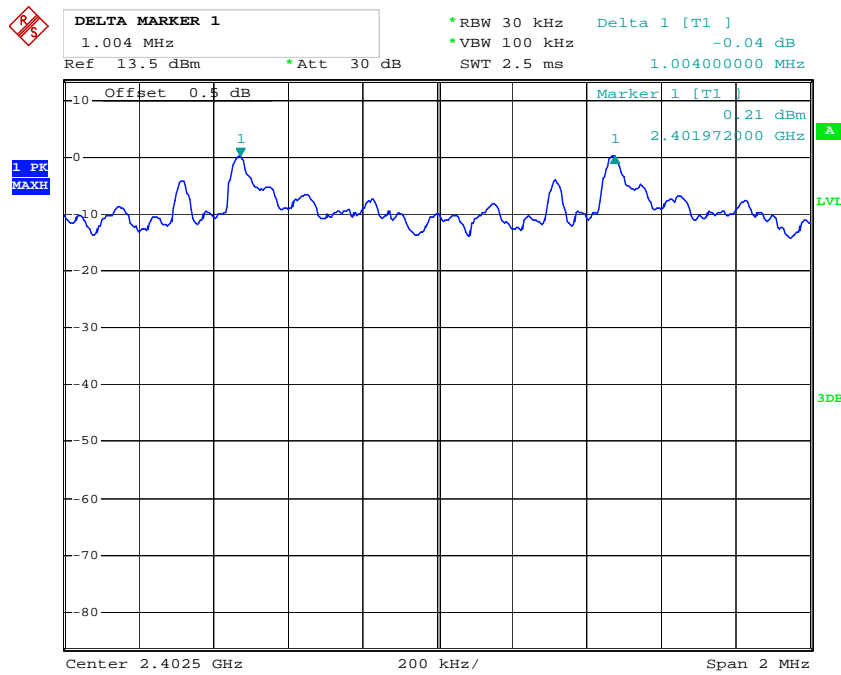
### High Channel



Date: 29.AUG.2014 17:51:59

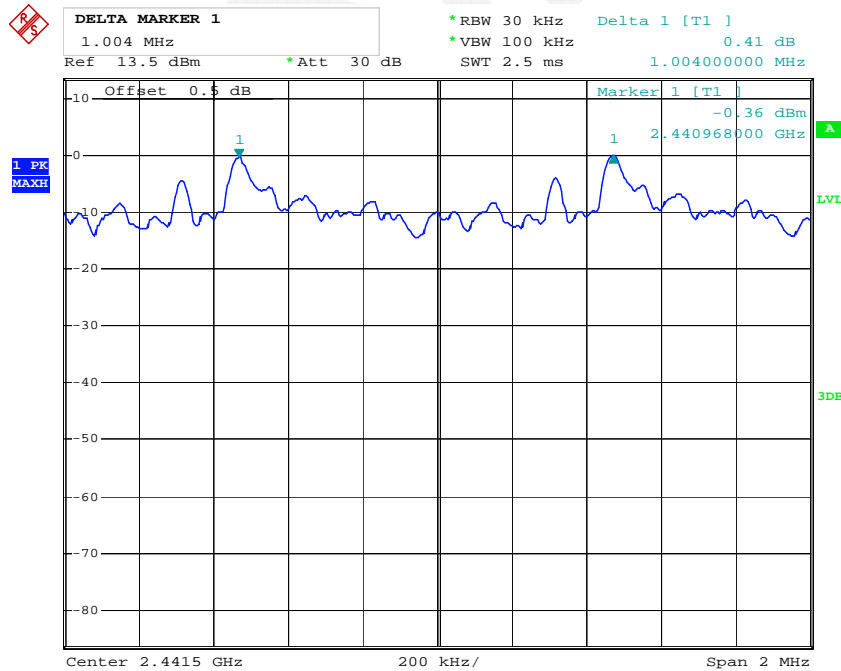
EDR Mode ( $\pi/4$ -DQPSK):

### Low Channel



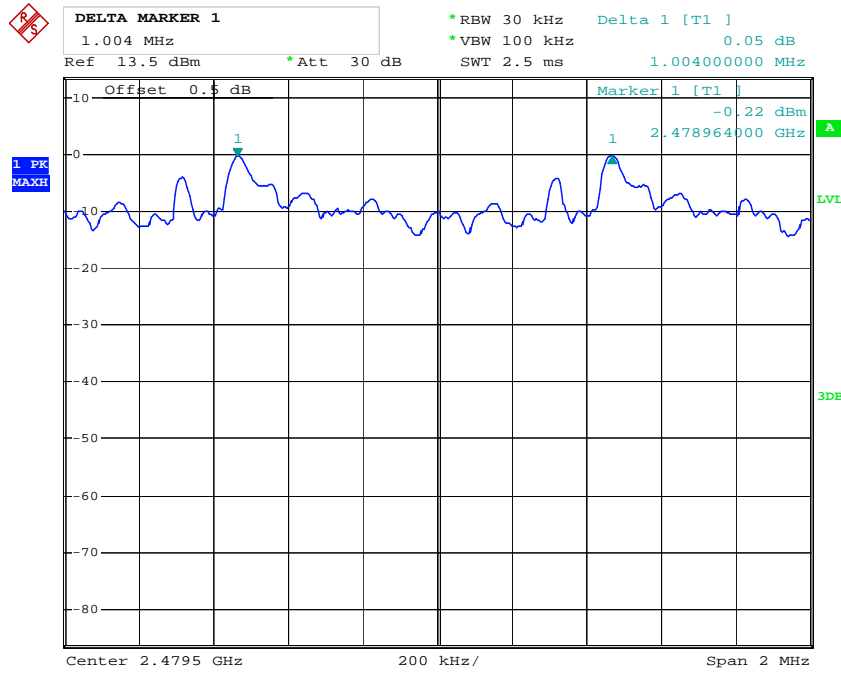
Date: 29.AUG.2014 18:09:04

### Middle Channel



Date: 29.AUG.2014 18:13:30

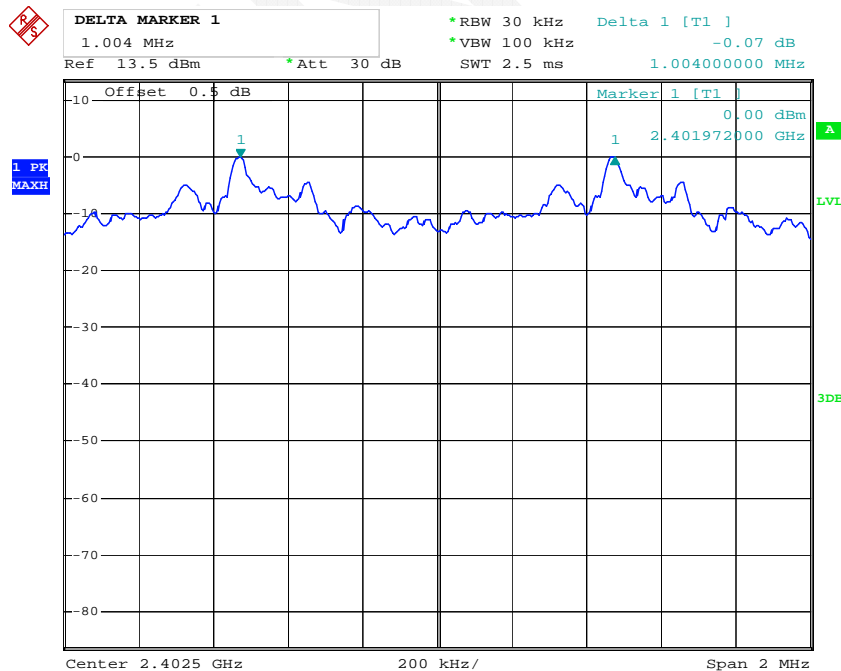
### High Channel



Date: 29.AUG.2014 18:19:37

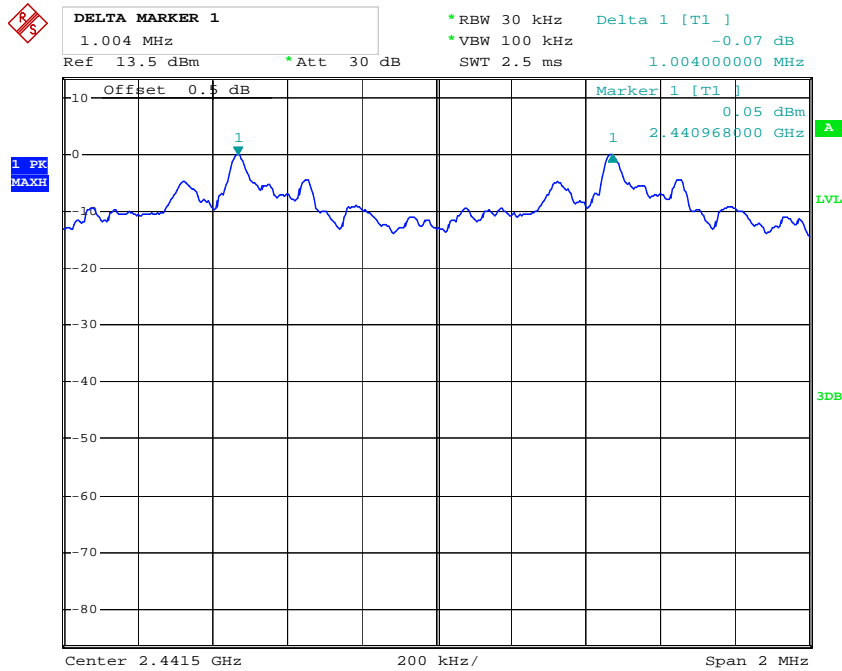
EDR Mode (8DPSK):

### Low Channel



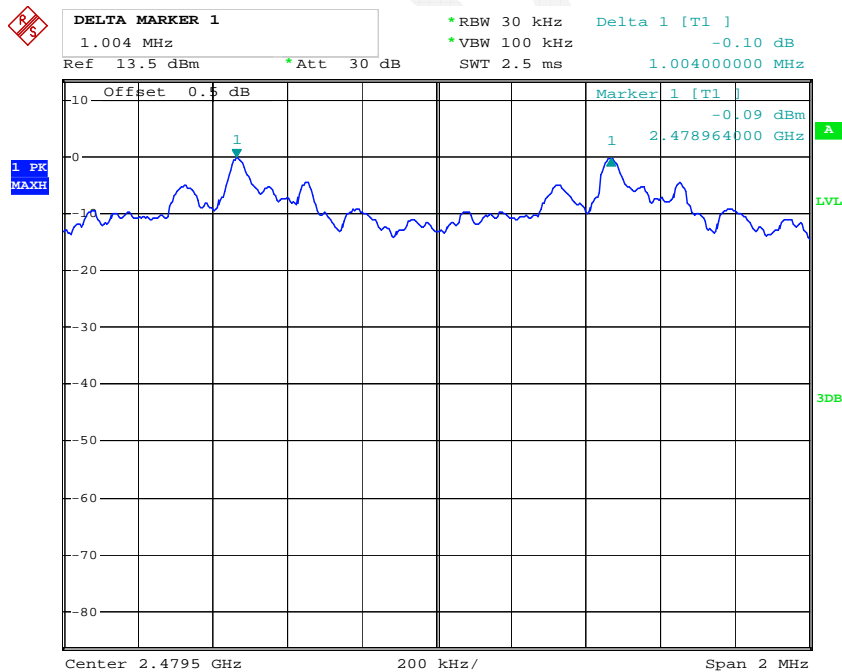
Date: 29.AUG.2014 18:30:38

### Middle Channel



Date: 29.AUG.2014 18:25:48

### High Channel



Date: 29.AUG.2014 18:21:36



## FCC §15.247(a) (1) – 20 dB BANDWIDTH TESTING

### Applicable Standard

Alternatively, frequency hopping systems operating in the 2400–2483.5 MHz band may have hopping channel carrier frequencies that are separated by 25 kHz or two-thirds of the 20 dB bandwidth of the hopping channel, whichever is greater, provided the systems operate with an output power no greater than 125 mW.

### Test Procedure

1. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
2. Position the EUT on the test table without connection to measurement instrument. Turn on the EUT. Then set it to any one convenient frequency within its operating range. Set a reference level on the measuring instrument equal to the highest peak value.
3. Measure the frequency difference of two frequencies that were attenuated 20 dB from the reference level. Record the frequency difference as the emission bandwidth.
4. Repeat above procedures until all frequencies measured were complete.

### Test Equipment List and Details

Manufacturer	Description	Model	Serial Number	Calibration Date	Calibration Due Date
R&S	Spectrum Analyzer	FSP 38	100478	2014-05-09	2015-05-08

\* **Statement of Traceability:** Bay Area Compliance Laboratories Corp. (Dongguan) attests that all calibrations have been performed, traceable to National Primary Standards and International System of Units (SI).

### Test Data

#### Environmental Conditions

<b>Temperature:</b>	30.1 °C
<b>Relative Humidity:</b>	60%
<b>ATM Pressure:</b>	100.8 kPa

*The testing was performed by Leon Chen on 2014-08-29.*

**Test Result:** Compliance.

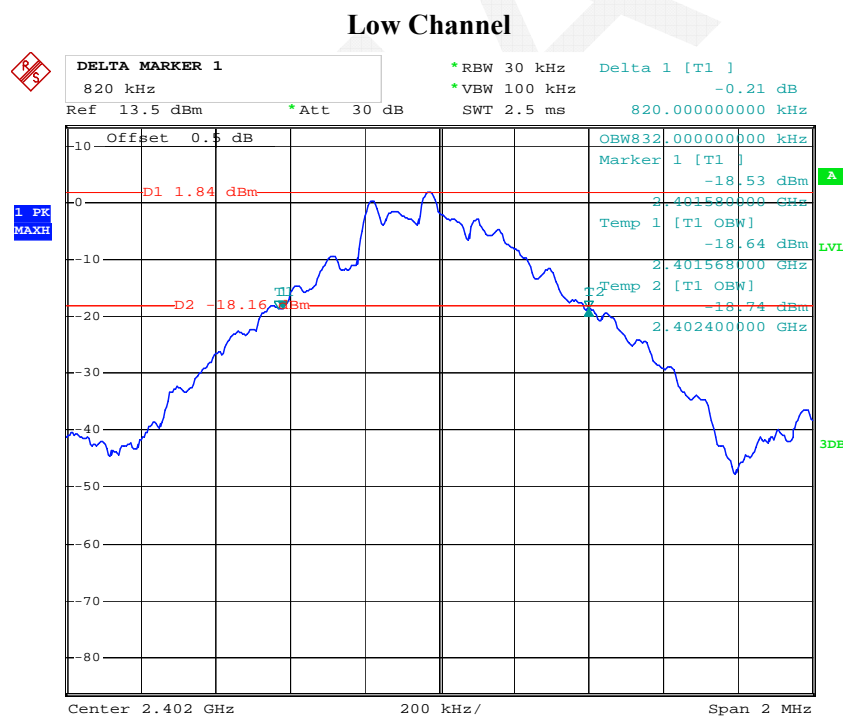
Please refer to following tables and plots

Test Mode: Transmitting

Mode	Channel	Frequency (MHz)	20 dB Bandwidth (MHz)
BDR Mode (GFSK)	Low	2402	0.820
	Middle	2441	0.840
	High	2480	0.856
EDR Mode ( $\pi/4$ -DQPSK)	Low	2402	1.212
	Middle	2441	1.216
	High	2480	1.224
EDR Mode (8DPSK)	Low	2402	1.208
	Middle	2441	1.216
	High	2480	1.212

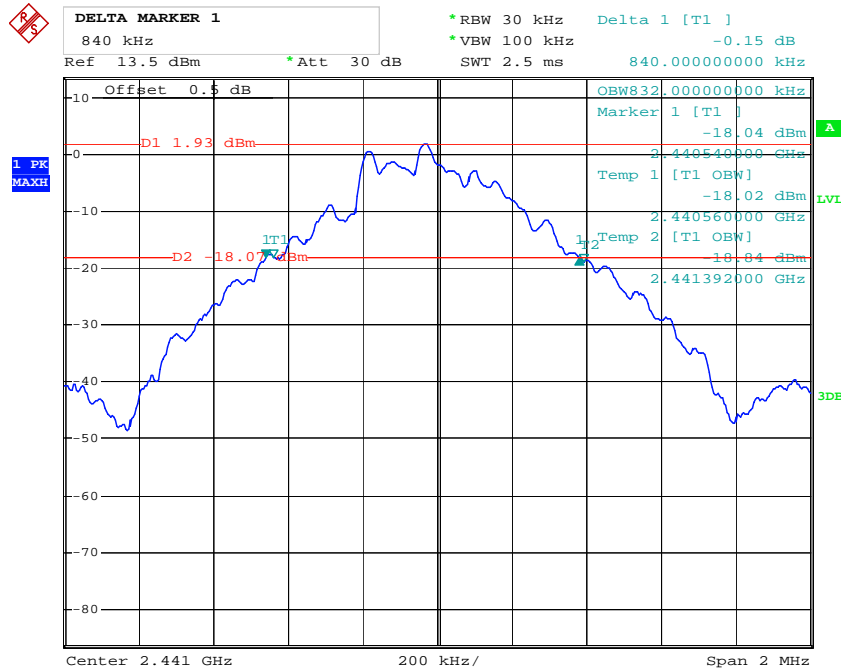
Please refer to the following plots.

BDR Mode (GFSK):



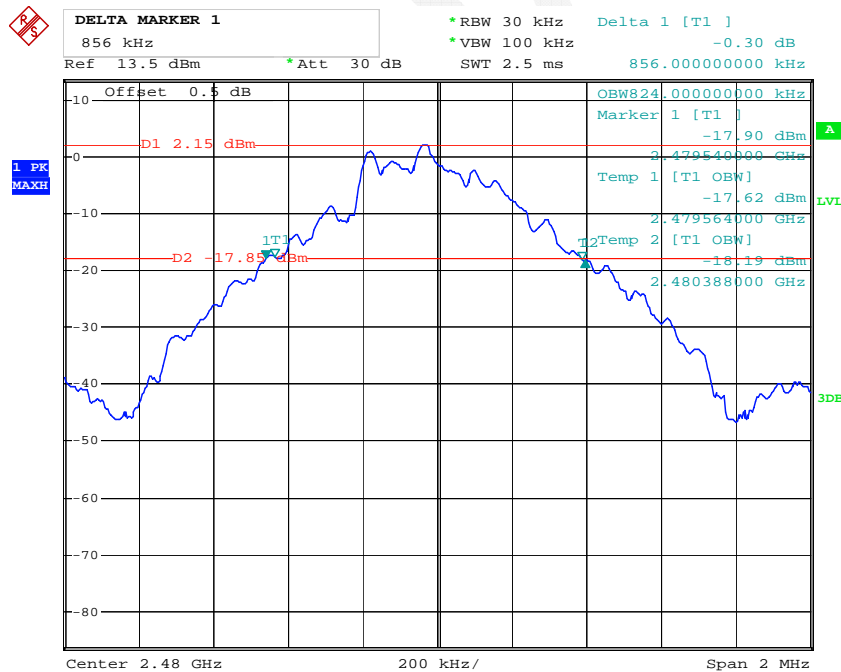
Date: 29.AUG.2014 18:00:18

### Middle Channel



Date: 29.AUG.2014 17:59:00

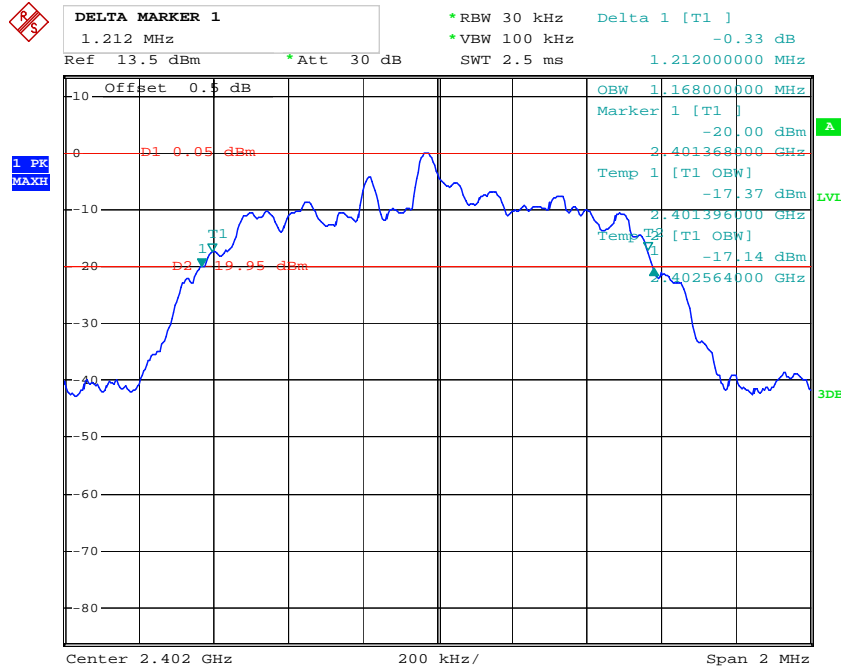
### High Channel



Date: 29.AUG.2014 17:53:02

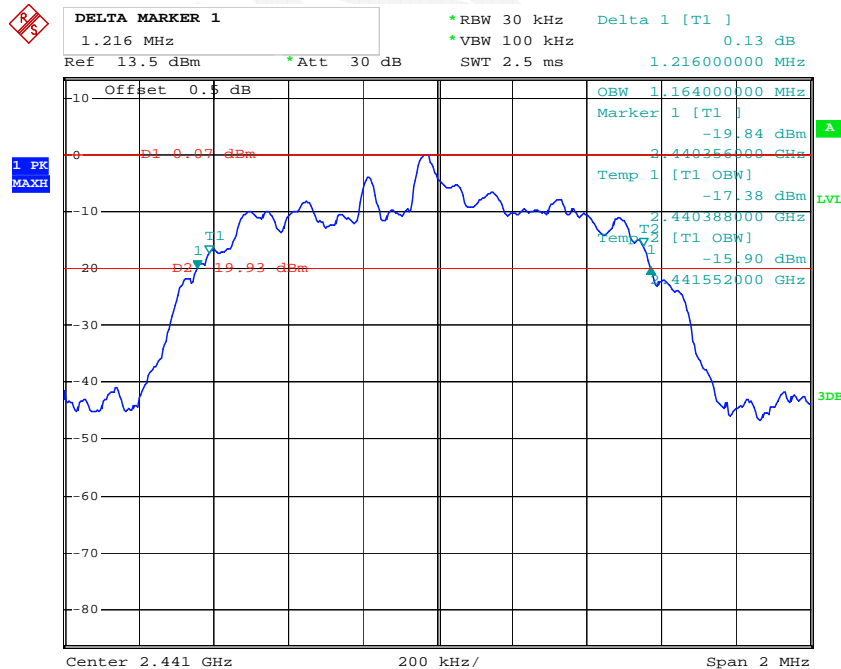
EDR Mode ( $\pi/4$ -DQPSK):

Low Channel



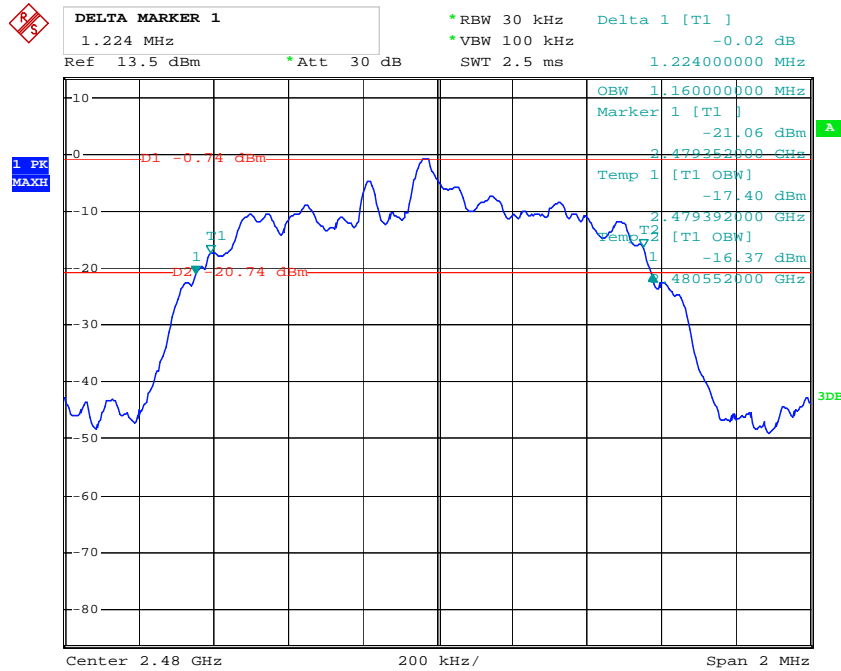
Date: 29.AUG.2014 18:10:28

Middle Channel



Date: 29.AUG.2014 18:14:34

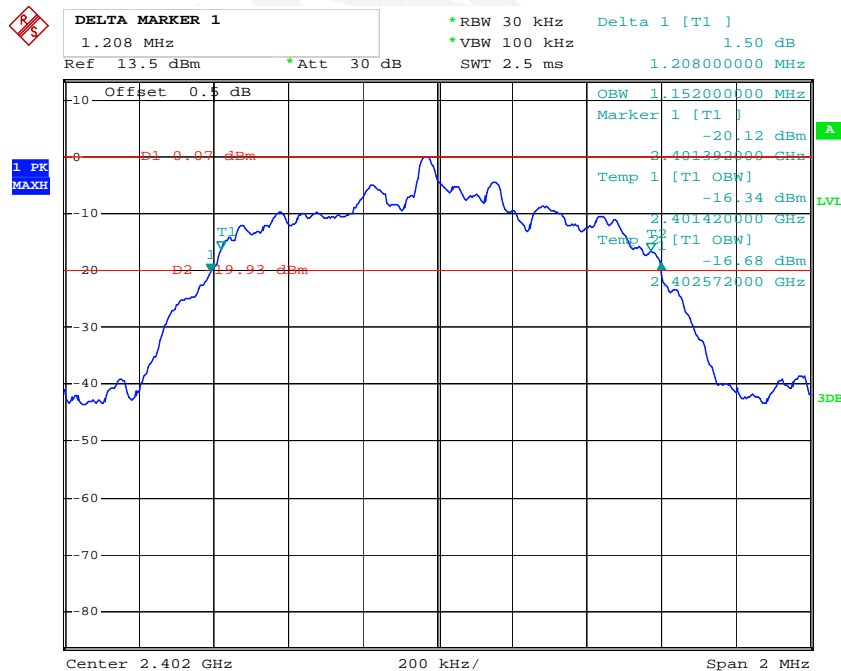
### High Channel



Date: 29.AUG.2014 19:29:38

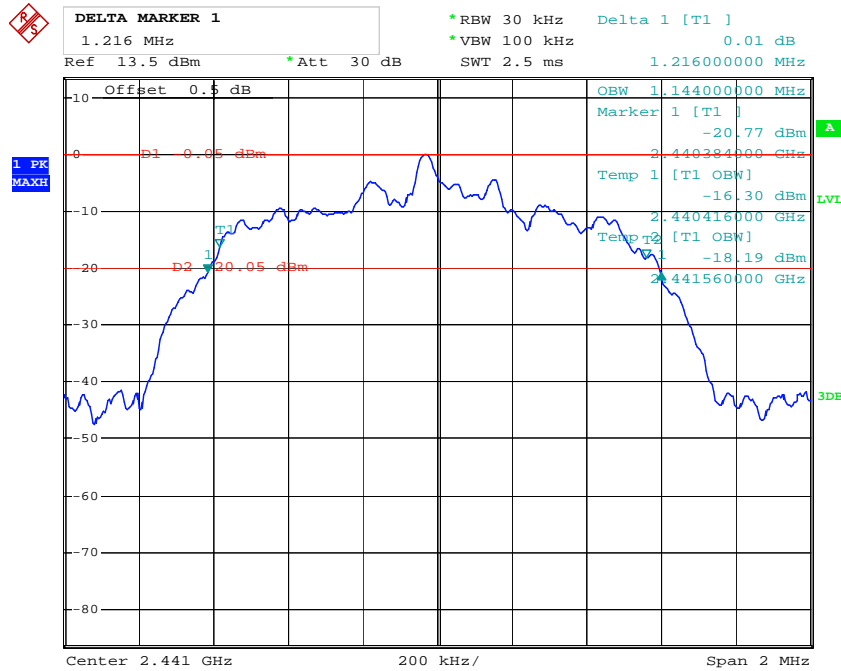
EDR Mode (8DPSK):

### Low Channel



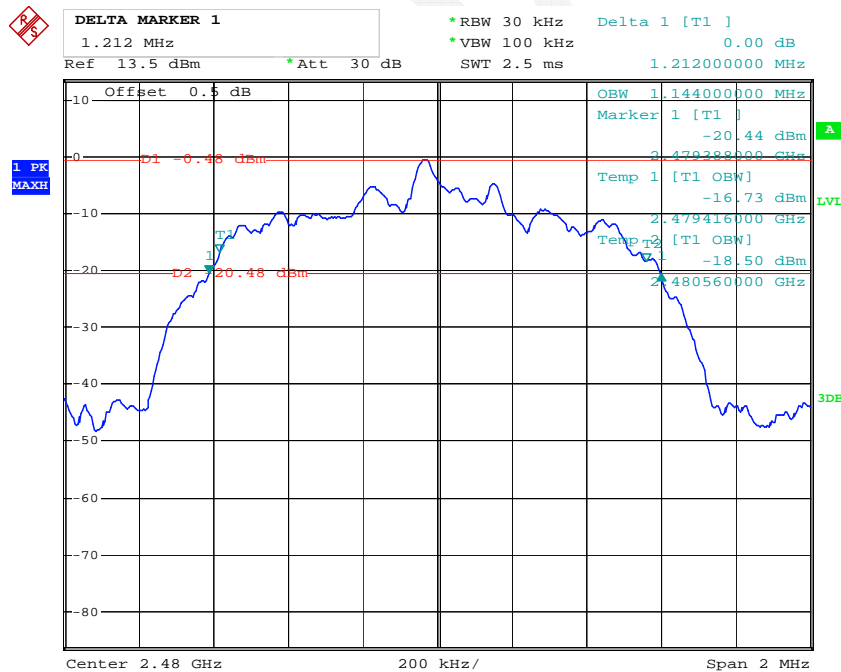
Date: 29.AUG.2014 18:29:44

### Middle Channel



Date: 29.AUG.2014 18:26:45

### High Channel



Date: 29.AUG.2014 18:22:38

## **FCC §15.247(a) (1) (iii) - QUANTITY OF HOPPING CHANNEL TEST**

### **Applicable Standard**

Frequency hopping systems in the 2400–2483.5 MHz band shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used.

### **Test Procedure**

1. Check the calibration of the measuring instrument (SA) using either an internal calibrator or a known signal from an external generator.
2. Set the EUT in hopping mode from first channel to last.
3. By using the Max-Hold function record the Quantity of the channel.

### **Test Equipment List and Details**

<b>Manufacturer</b>	<b>Description</b>	<b>Model</b>	<b>Serial Number</b>	<b>Calibration Date</b>	<b>Calibration Due Date</b>
R&S	Spectrum Analyzer	FSP 38	100478	2014-05-09	2015-05-08

\* **Statement of Traceability:** Bay Area Compliance Laboratories Corp. (Dongguan) attests that all calibrations have been performed, traceable to National Primary Standards and International System of Units (SI).

### **Test Data**

#### **Environmental Conditions**

<b>Temperature:</b>	30.1 °C
<b>Relative Humidity:</b>	60%
<b>ATM Pressure:</b>	100.8 kPa

*The testing was performed by Leon Chen on 2014-08-29.*

**Test Result:** Compliant.

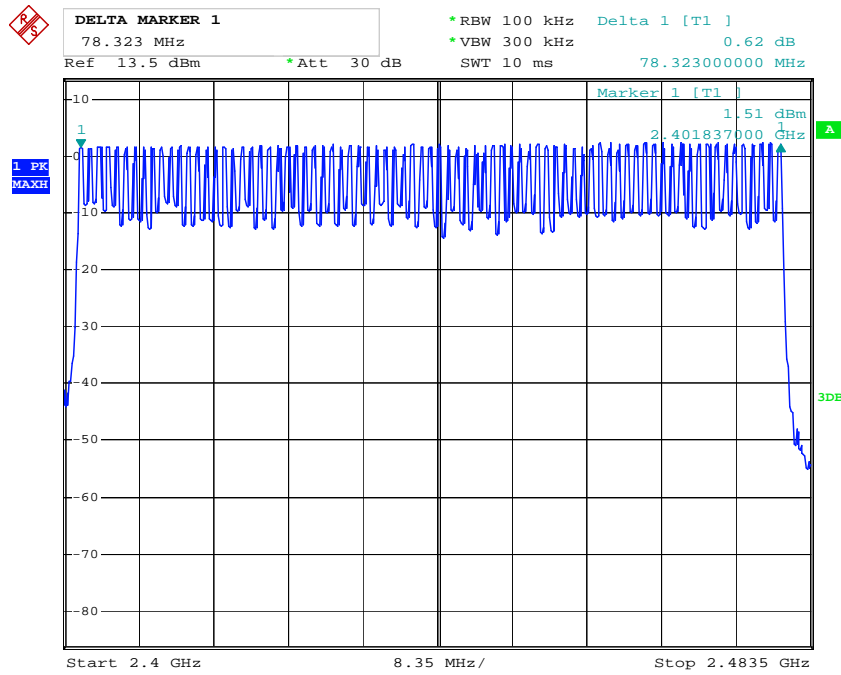
Please refer to following tables and plots

Test Mode: Transmitting

BDR Mode (GFSK):

Frequency Range (MHz)	Number of Hopping Channel	Limit
2400-2483.5	79	≥15

Number of Hopping Channels



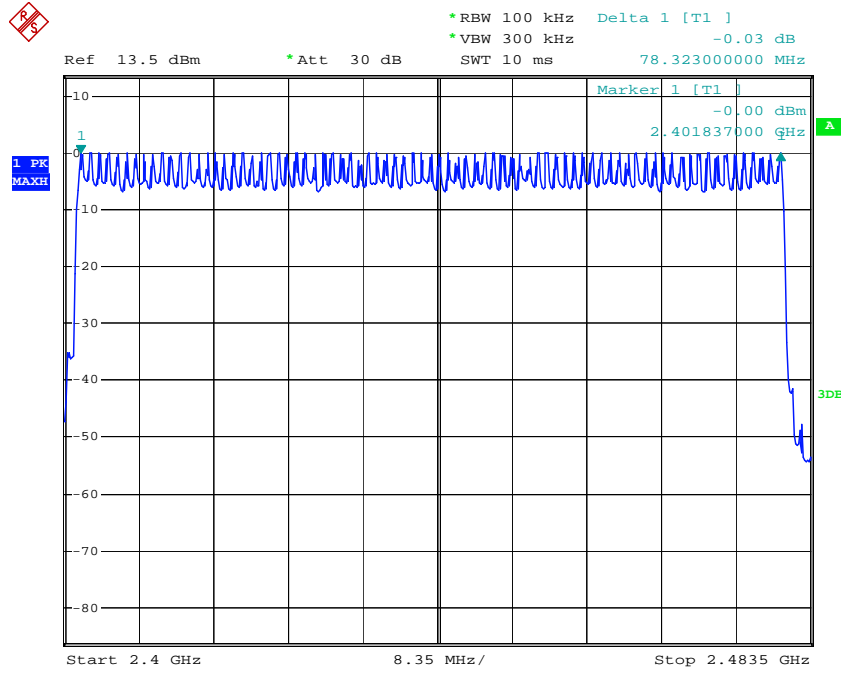
Date: 29.AUG.2014 19:16:02



EDR Mode ( $\pi/4$ -DQPSK):

Frequency Range (MHz)	Number of Hopping Channel	Limit
2400-2483.5	79	$\geq 15$

Number of Hopping Channels

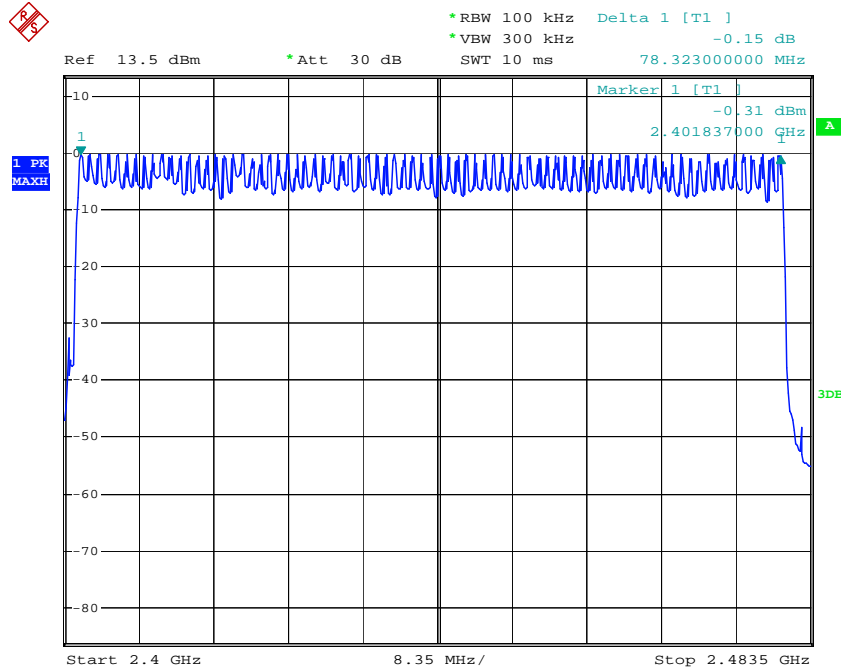


Date: 29.AUG.2014 19:20:33

EDR Mode (8DPSK):

Frequency Range (MHz)	Number of Hopping Channel	Limit
2400-2483.5	79	≥15

Number of Hopping Channels



Date: 29.AUG.2014 19:24:50

## **FCC §15.247(a) (1) (iii) - TIME OF OCCUPANCY (DWELL TIME)**

### **Applicable Standard**

Frequency hopping systems in the 2400-2483.5 MHz shall use at least 15 channels. The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed. Frequency hopping systems may avoid or suppress transmissions on a particular hopping frequency provided that a minimum of 15 channels are used.

### **Test Procedure**

The EUT was worked in channel hopping; Spectrum SPAN was set as 0. Sweep was set as 0.4 \* channel no. (s), the quantity of pulse was get from single sweep. In addition, the time of single pulses was tested.

Dwell Time= time slot length \* hope rate/ number of hopping channels \* 31.6s  
Hop rate=1600/s

### **Test Equipment List and Details**

Manufacturer	Description	Model	Serial Number	Calibration Date	Calibration Due Date
R&S	Spectrum Analyzer	FSP 38	100478	2014-05-09	2015-05-08

\* **Statement of Traceability:** Bay Area Compliance Laboratories Corp. (Dongguan) attests that all calibrations have been performed, traceable to National Primary Standards and International System of Units (SI).

### **Test Data**

#### **Environmental Conditions**

<b>Temperature:</b>	30.1 °C
<b>Relative Humidity:</b>	60%
<b>ATM Pressure:</b>	100.8 kPa

*The testing was performed by Leon Chen on 2014-08-29.*

**Test Result:** Compliant.

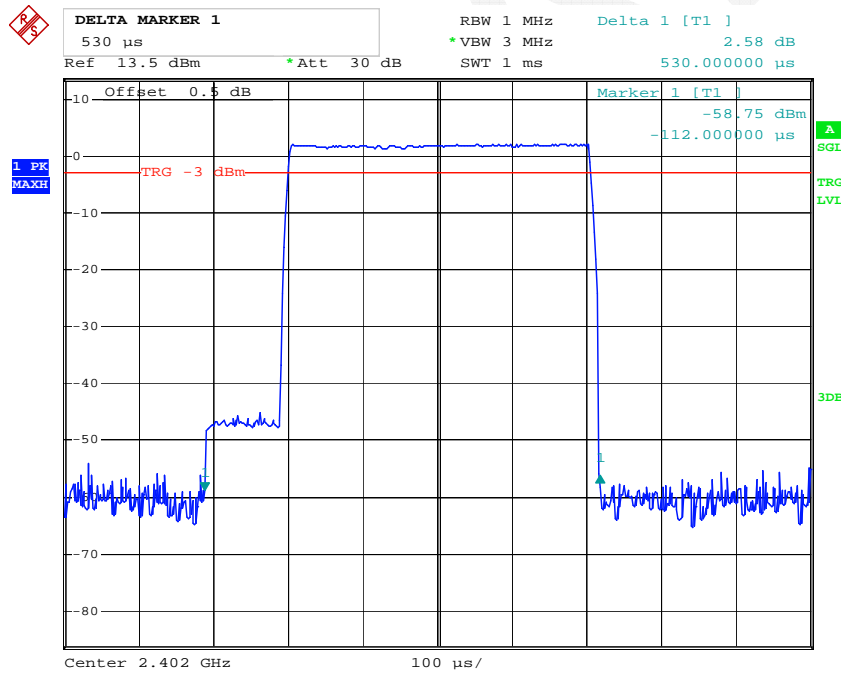
Please refer to following tables and plots

Test Mode: Transmitting

BDR Mode (GFSK):

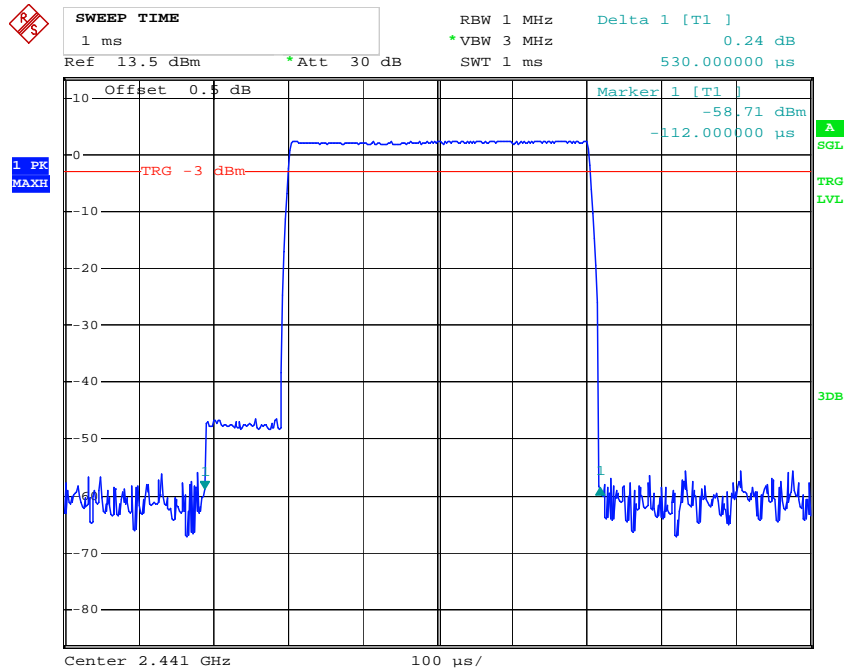
Mode	Channel	Pulse Width (ms)	Dwell Time (s)	Limit (s)	Result
DH1	Low	0.530	0.170	0.4	Pass
	Middle	0.530	0.170	0.4	Pass
	High	0.530	0.170	0.4	Pass
	Note: Dwell time=Pulse time (ms) × (1600/2/79) ×31.6 s				
DH3	Low	1.796	0.287	0.4	Pass
	Middle	1.796	0.287	0.4	Pass
	High	1.796	0.287	0.4	Pass
	Note: Dwell time=Pulse time (ms) × (1600/4/79) ×31.6 s				
DH5	Low	3.062	0.327	0.4	Pass
	Middle	3.062	0.327	0.4	Pass
	High	3.062	0.327	0.4	Pass
	Note: Dwell time=Pulse time (ms) × (1600/6/79) ×31.6 s				

DH1: Low Channel



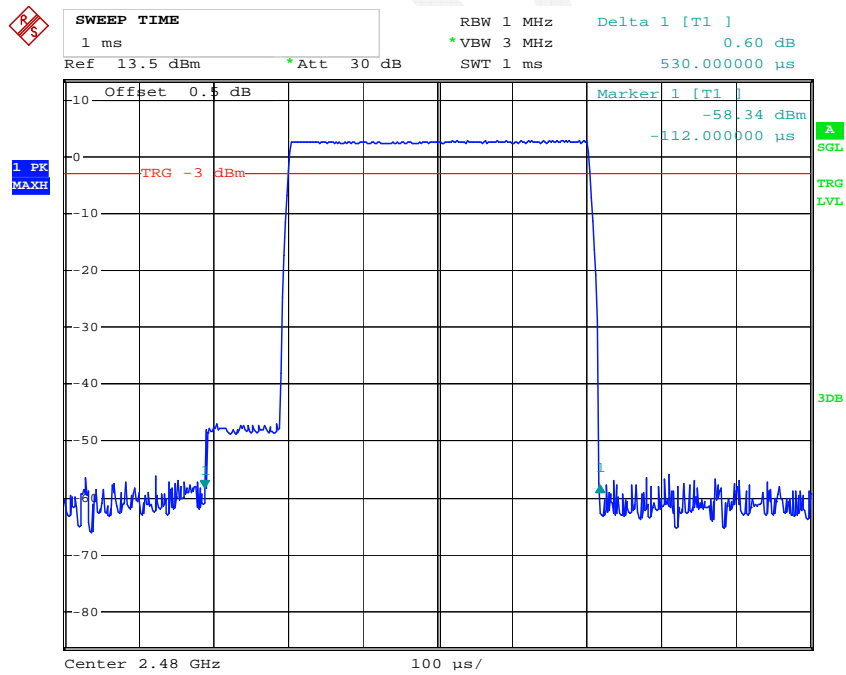
Date: 29.AUG.2014 18:41:26

**DH1: Middle Channel**



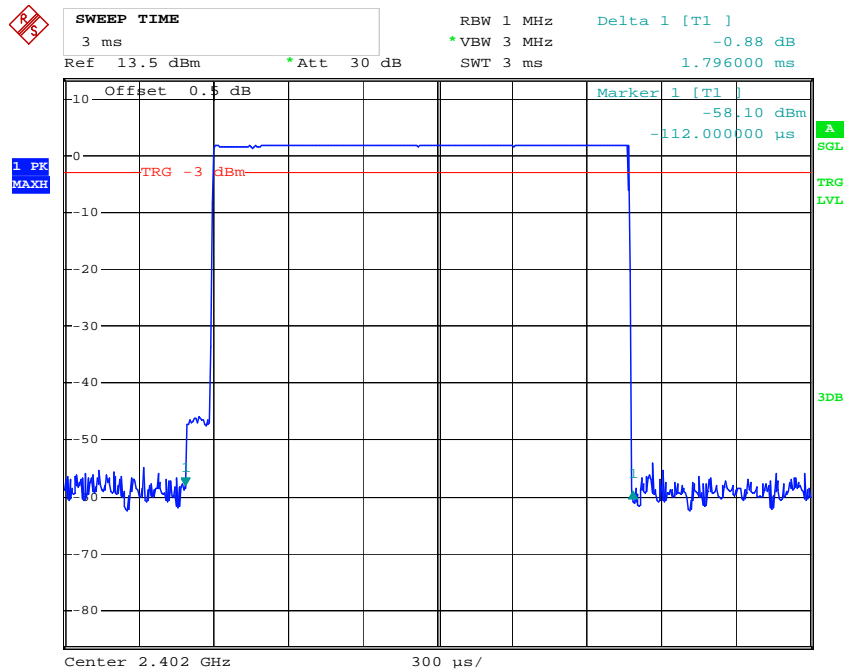
Date: 29.AUG.2014 18:41:53

**DH1: High Channel**



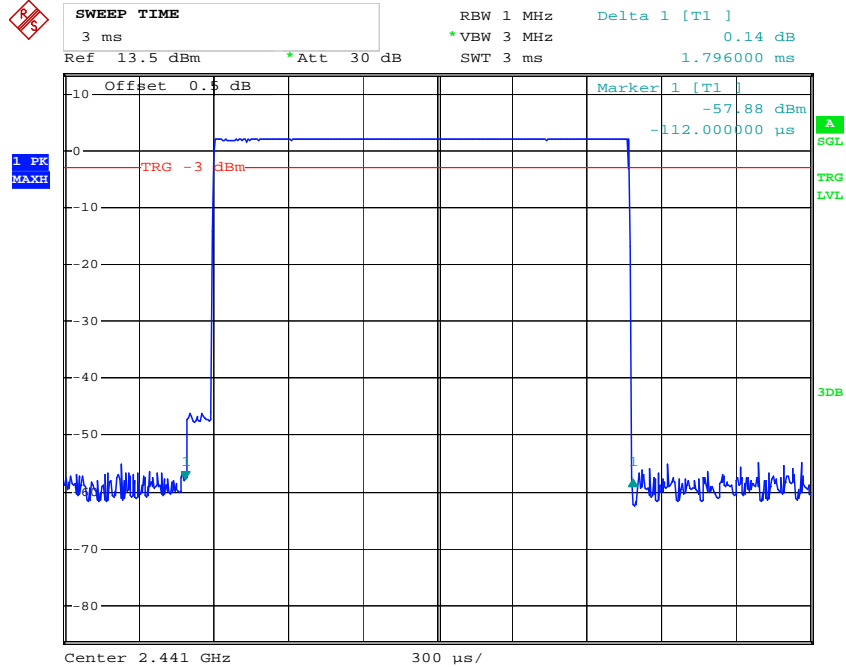
Date: 29.AUG.2014 18:42:16

### DH3: Low Channel



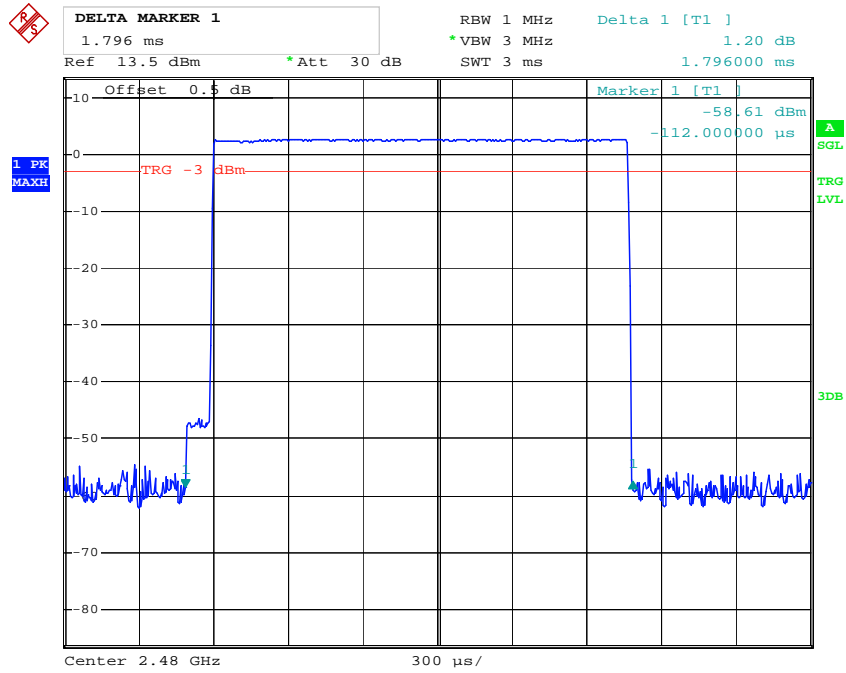
Date: 29.AUG.2014 18:44:57

### DH3: Middle Channel



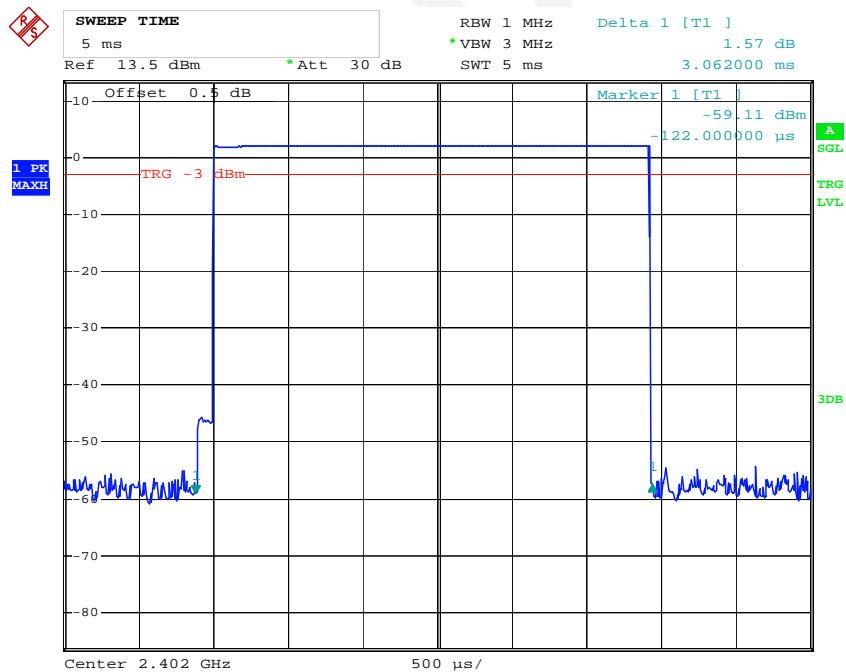
Date: 29.AUG.2014 18:44:19

### DH3: High Channel



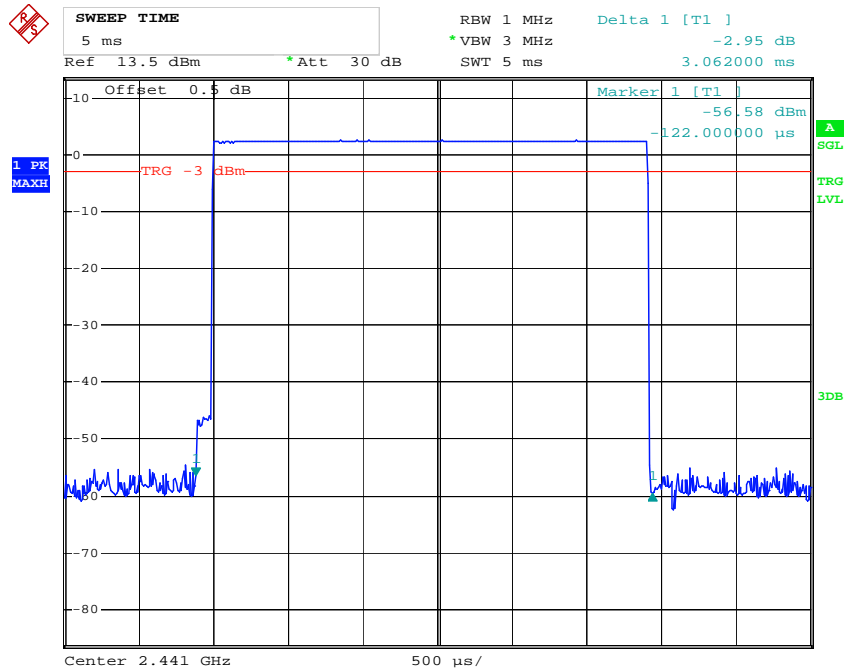
Date: 29.AUG.2014 18:44:07

### DH5: Low Channel



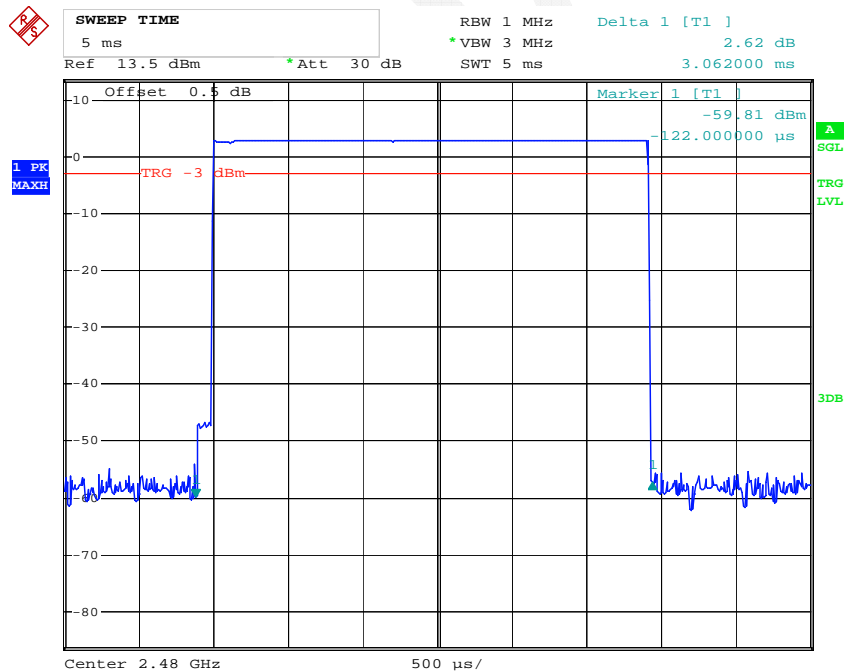
Date: 29.AUG.2014 19:07:29

### DH5: Middle Channel



Date: 29.AUG.2014 19:07:37

### DH5: High Channel



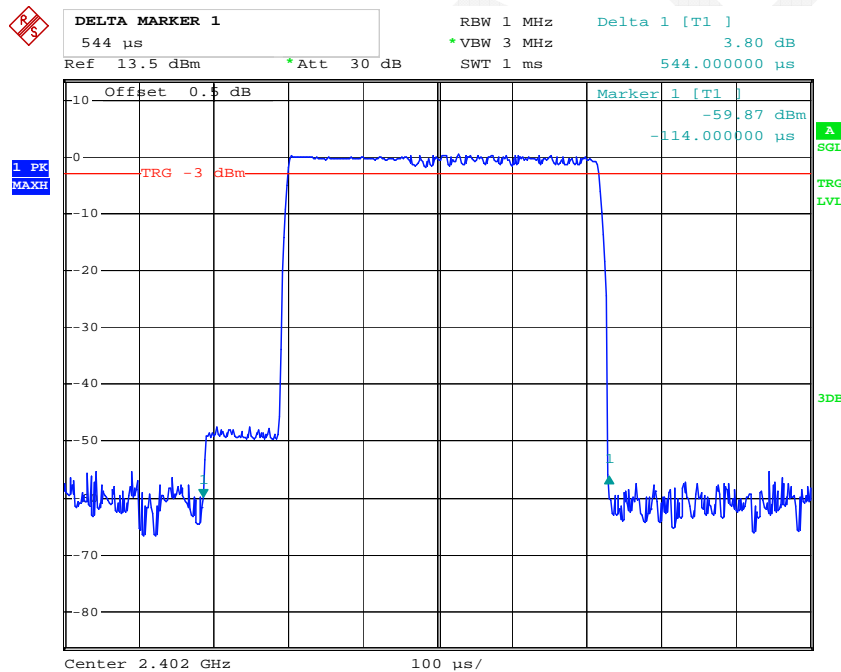
Date: 29.AUG.2014 19:07:48



EDR Mode ( $\pi/4$ -DQPSK):

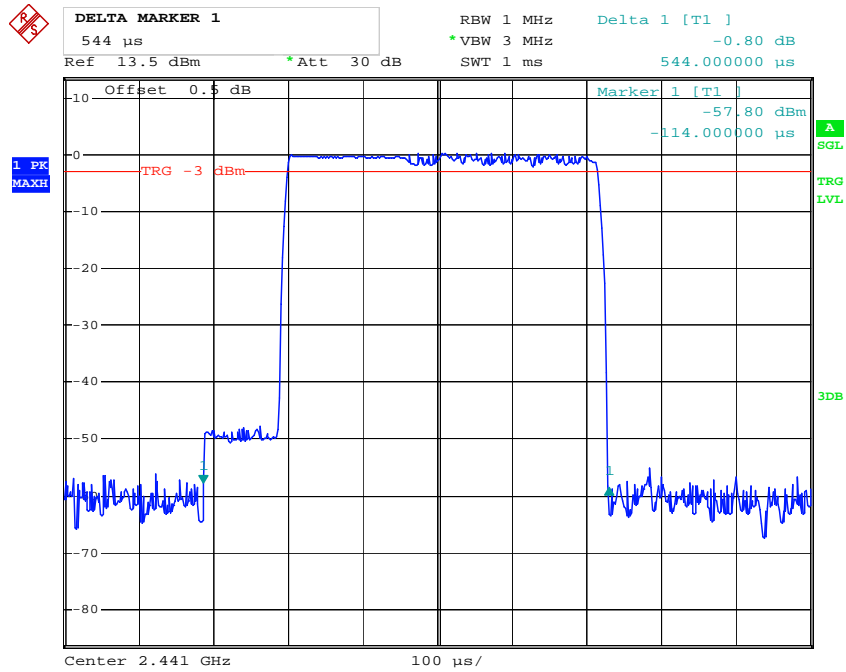
Mode	Channel	Pulse Width (ms)	Dwell Time (s)	Limit (s)	Result
DH1	Low	0.544	0.174	0.4	Pass
	Middle	0.544	0.174	0.4	Pass
	High	0.544	0.174	0.4	Pass
	Note: Dwell time=Pulse time (ms) × (1600/2/79) ×31.6 s				
DH3	Low	1.688	0.270	0.4	Pass
	Middle	1.688	0.270	0.4	Pass
	High	1.688	0.270	0.4	Pass
	Note: Dwell time=Pulse time (ms) × (1600/4/79) ×31.6 s				
DH5	Low	3.072	0.328	0.4	Pass
	Middle	3.072	0.328	0.4	Pass
	High	3.072	0.328	0.4	Pass
	Note: Dwell time=Pulse time (ms) × (1600/6/79) ×31.6 s				

DH1: Low Channel



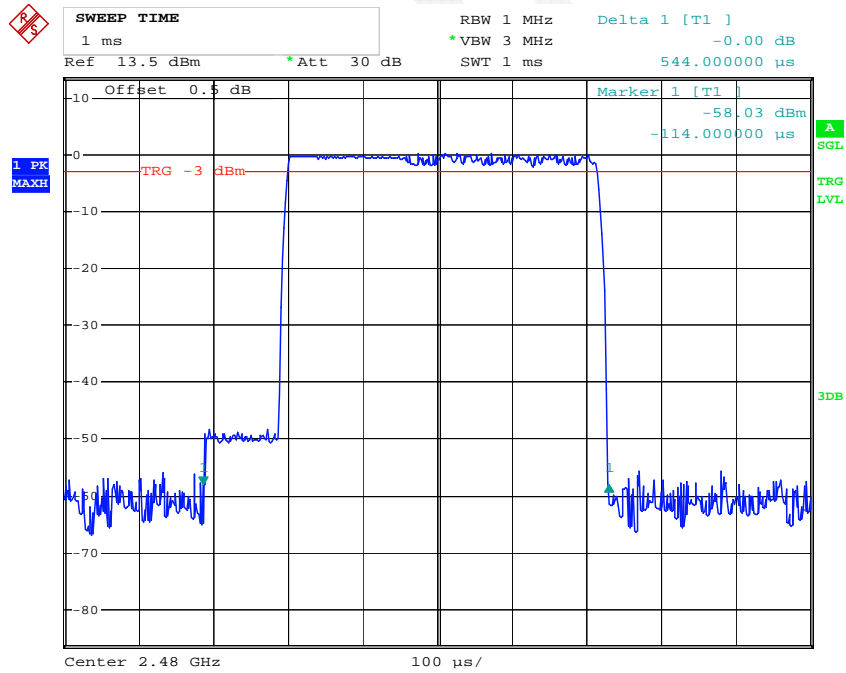
Date: 29.AUG.2014 18:40:31

### DH1: Middle Channel



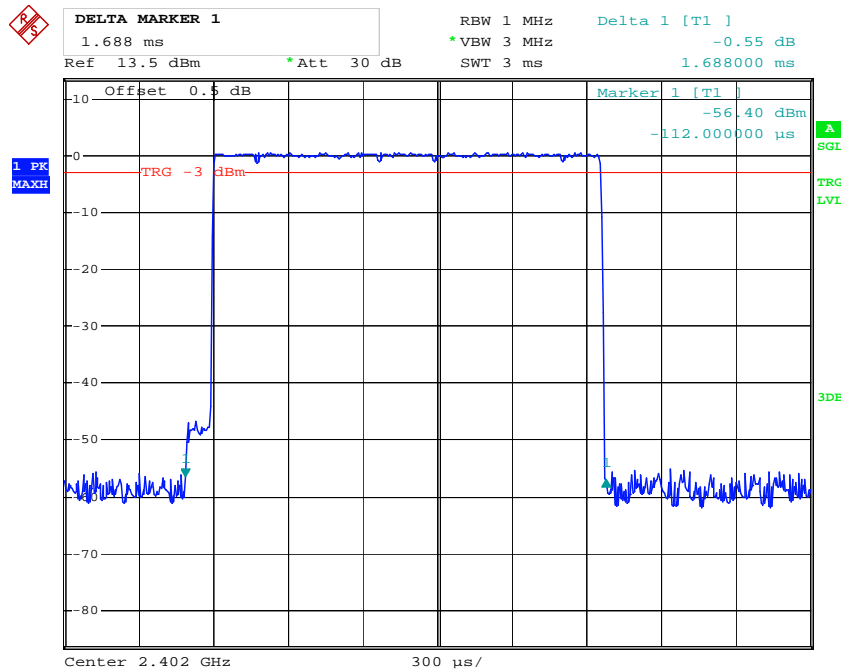
Date: 29.AUG.2014 18:39:56

### DH1: High Channel



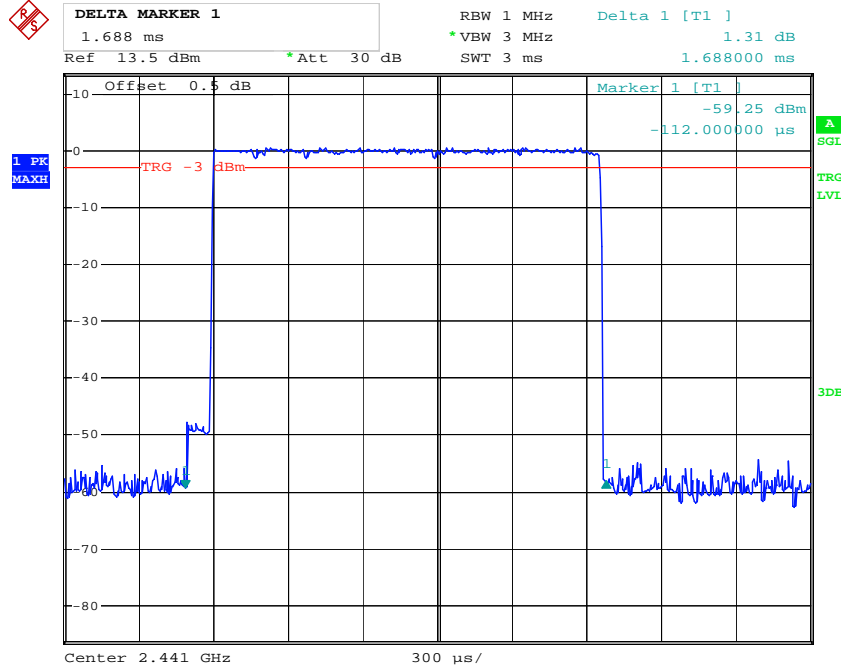
Date: 29.AUG.2014 18:39:11

**DH3: Low Channel**



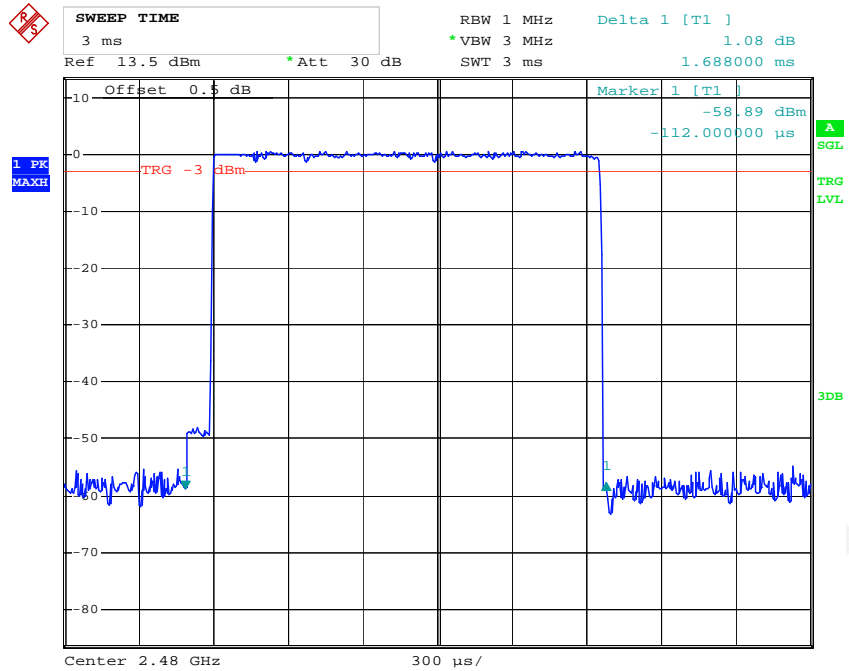
Date: 29.AUG.2014 18:45:40

**DH3: Middle Channel**



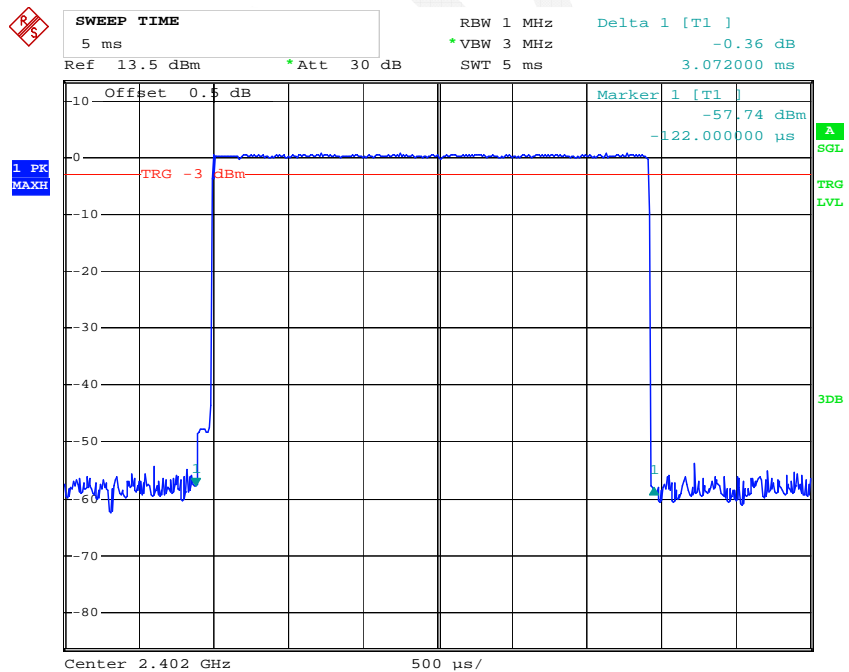
Date: 29.AUG.2014 18:46:08

### DH3: High Channel



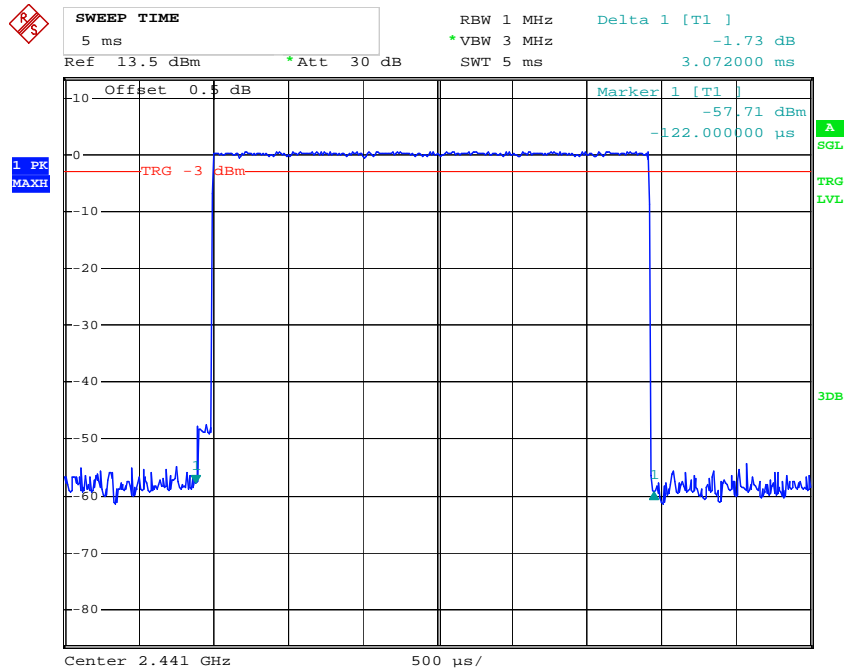
Date: 29.AUG.2014 18:46:26

### DH5: Low Channel



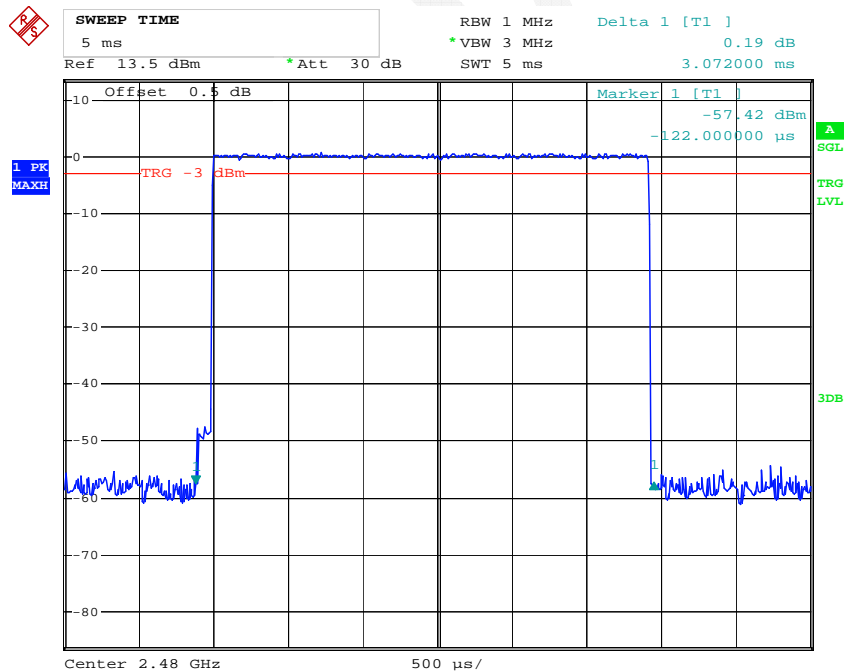
Date: 29.AUG.2014 19:06:49

**DH5: Middle Channel**



Date: 29.AUG.2014 19:06:09

**DH5: High Channel**

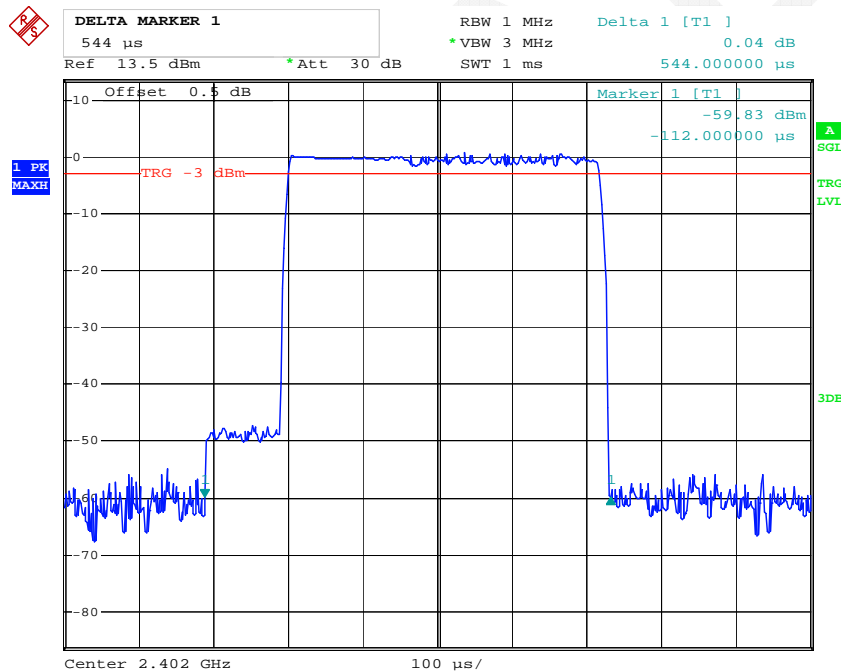


Date: 29.AUG.2014 19:05:56

EDR Mode (8DPSK):

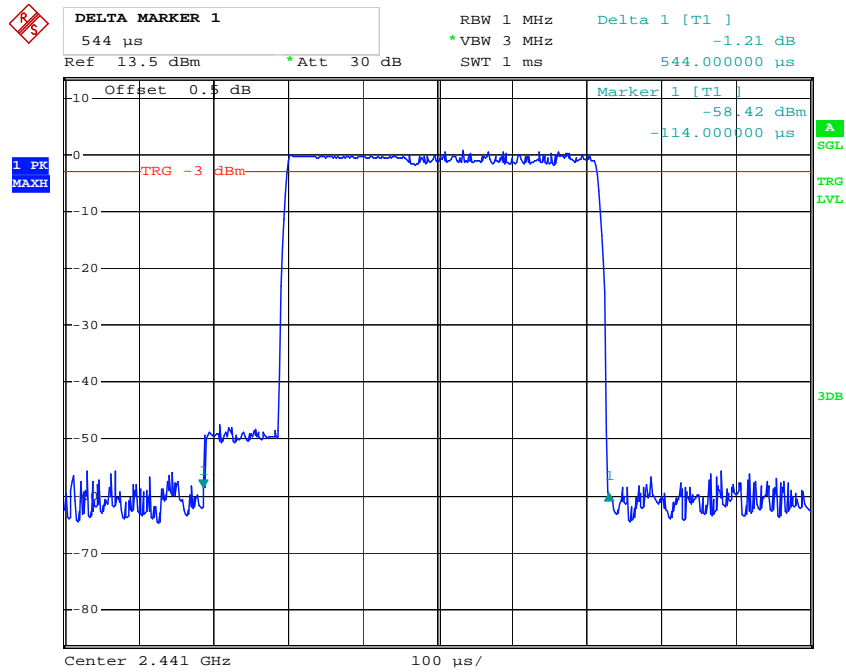
Mode	Channel	Pulse Width (ms)	Dwell Time (s)	Limit (s)	Result
DH1	Low	0.544	0.174	0.4	Pass
	Middle	0.544	0.174	0.4	Pass
	High	0.544	0.174	0.4	Pass
	Note: Dwell time=Pulse time (ms) × (1600/2/79) ×31.6 s				
DH3	Low	1.802	0.288	0.4	Pass
	Middle	1.802	0.288	0.4	Pass
	High	1.802	0.288	0.4	Pass
	Note: Dwell time=Pulse time (ms) × (1600/4/79) ×31.6 s				
DH5	Low	3.072	0.328	0.4	Pass
	Middle	3.072	0.328	0.4	Pass
	High	3.072	0.328	0.4	Pass
	Note: Dwell time=Pulse time (ms) × (1600/6/79) ×31.6 s				

DH1: Low Channel



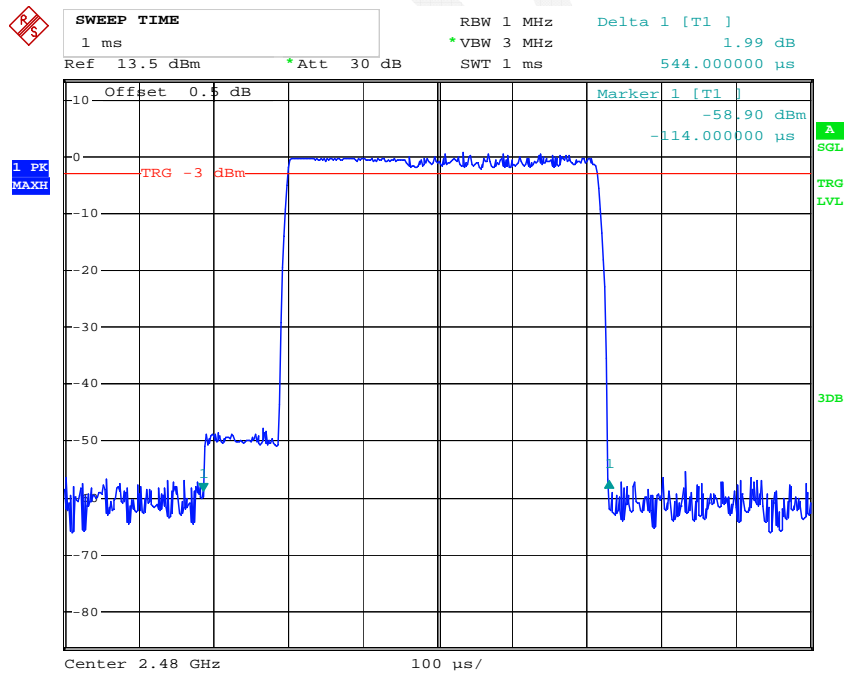
Date: 29.AUG.2014 18:38:01

**DH1: Middle Channel**



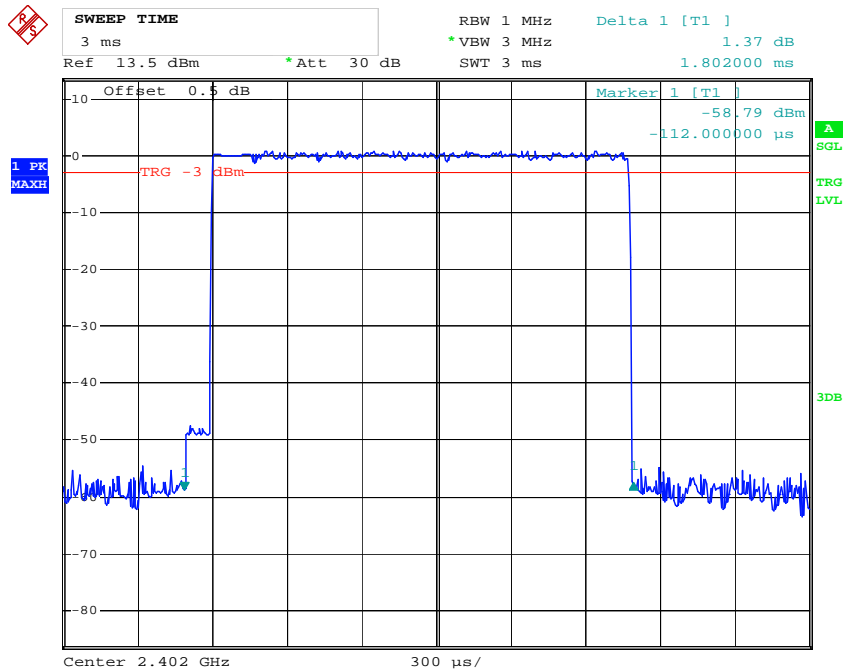
Date: 29.AUG.2014 18:38:40

**DH1: High Channel**



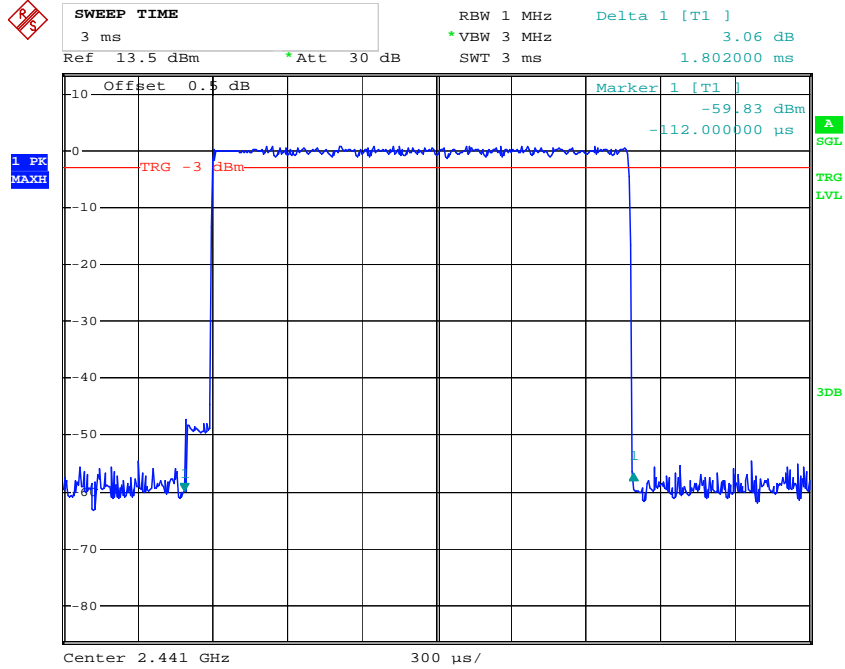
Date: 29.AUG.2014 18:38:52

**DH3: Low Channel**



Date: 29.AUG.2014 18:47:48

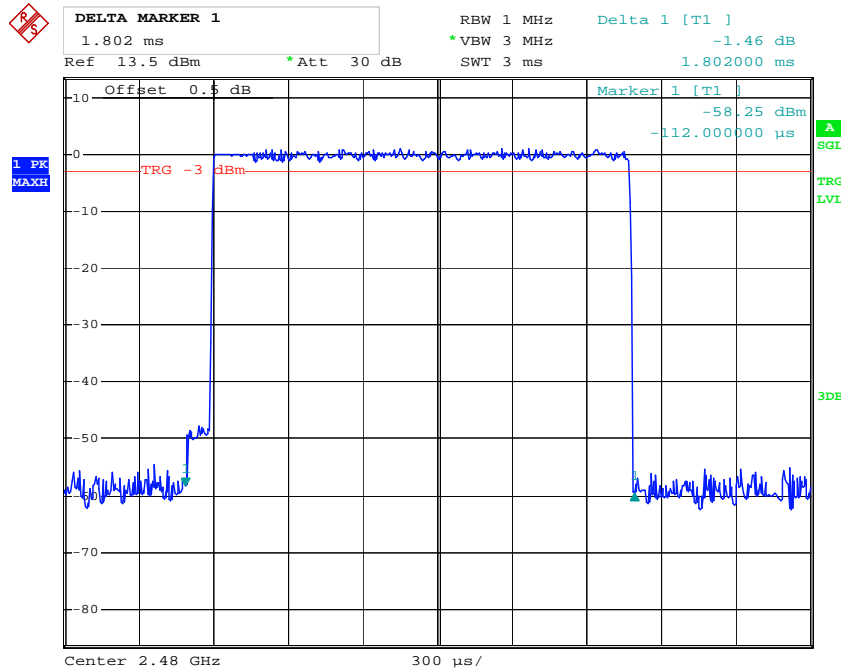
**DH3: Middle Channel**



Date: 29.AUG.2014 18:47:29

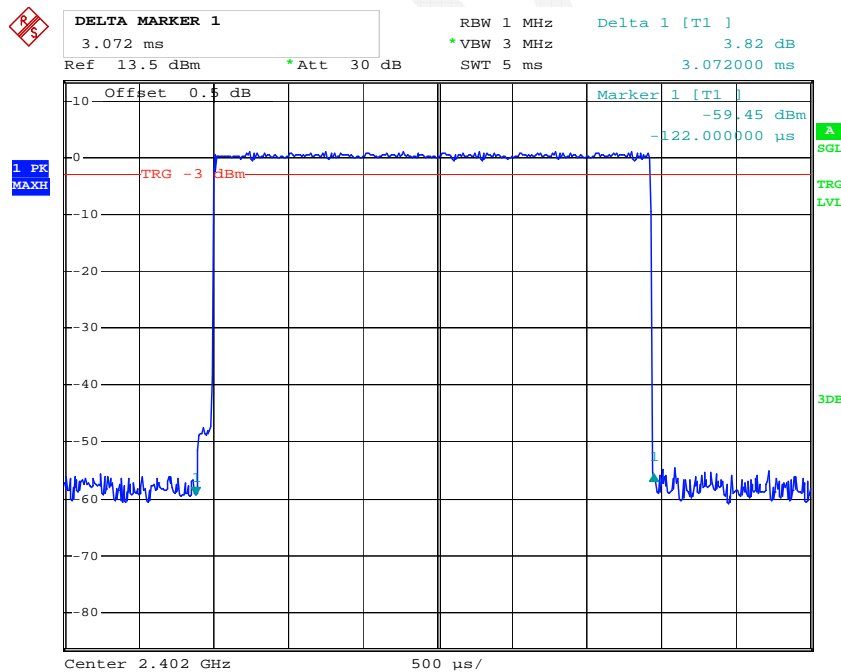


### DH3: High Channel



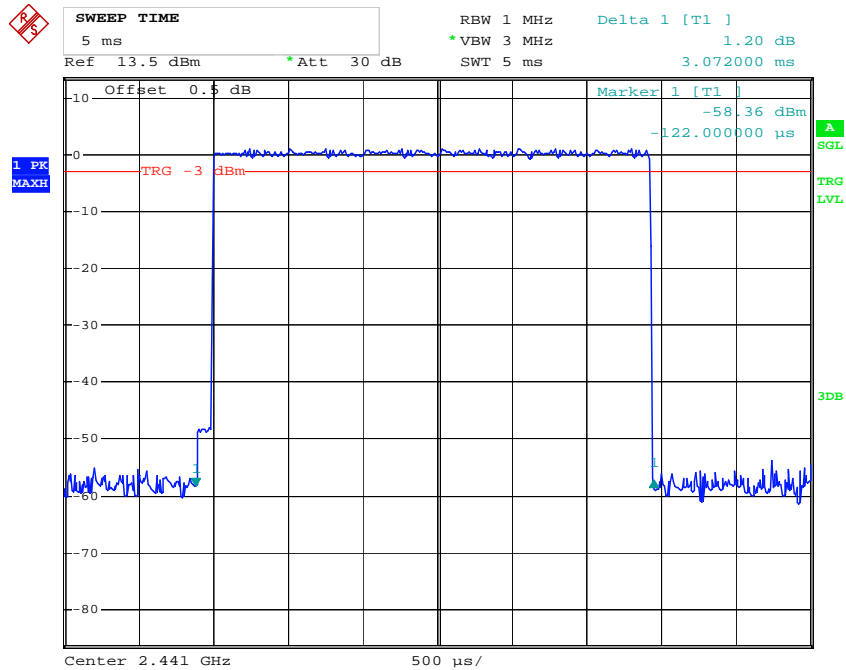
Date: 29.AUG.2014 18:47:05

### DH5: Low Channel



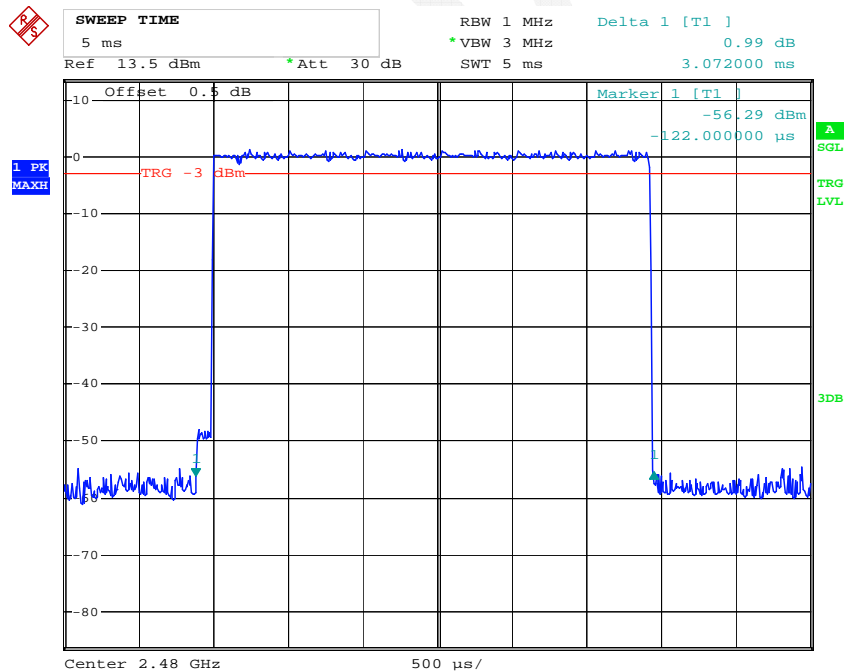
Date: 29.AUG.2014 19:05:00

**DH5: Middle Channel**



Date: 29.AUG.2014 19:05:10

**DH5: High Channel**



Date: 29.AUG.2014 19:05:31

## FCC §15.247(b) (1) - PEAK OUTPUT POWER MEASUREMENT

### Applicable Standard

According to §15.247(b) (1), for frequency hopping systems operating in the 2400–2483.5 MHz band employing at least 75 non-overlapping hopping channels, and all frequency hopping systems in the 5725–5850 MHz band: 1 watt. For all other frequency hopping systems in the 2400–2483.5 MHz band: 0.125 watts

### Test Procedure

1. Place the EUT on a bench and set in transmitting mode.
2. Remove the antenna from the EUT and then connect a low loss RF cable from the antenna port to test equipment.
3. Add a correction factor to the display.

### Test Equipment List and Details

Manufacturer	Description	Model	Serial Number	Calibration Date	Calibration Due Date
R&S	Spectrum Analyzer	FSP 38	100478	2014-05-09	2015-05-08

\* **Statement of Traceability:** Bay Area Compliance Laboratories Corp. (Dongguan) attests that all calibrations have been performed, traceable to National Primary Standards and International System of Units (SI).

### Test Data

#### Environmental Conditions

<b>Temperature:</b>	30.1 °C
<b>Relative Humidity:</b>	60%
<b>ATM Pressure:</b>	100.8 kPa

*The testing was performed by Leon Chen on 2014-08-29.*

**Test Result:** Compliant.

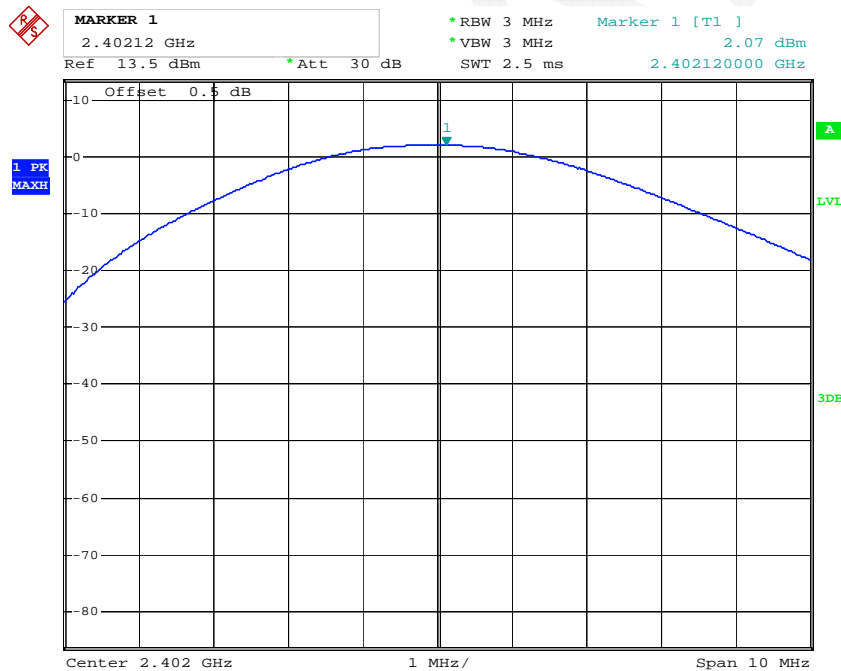
Test Mode: Transmitting

Mode	Channel	Frequency (MHz)	Peak Output Power (dBm)	Limit (dBm)
BDR Mode (GFSK)	Low	2402	2.07	30
	Middle	2441	2.26	30
	High	2480	2.68	30
EDR Mode ( $\pi/4$ -DQPSK)	Low	2402	0.94	30
	Middle	2441	0.73	30
	High	2480	1.01	30
EDR Mode (8DPSK)	Low	2402	1.23	30
	Middle	2441	1.32	30
	High	2480	1.44	30

Note: The data above was tested in conducted mode.

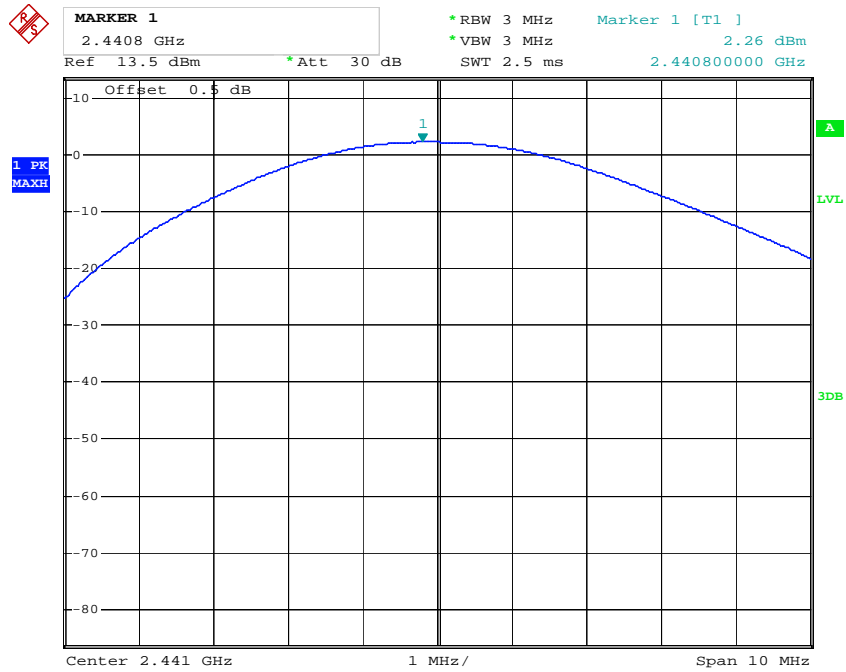
BDR Mode (GFSK):

Output Power, Low Channel



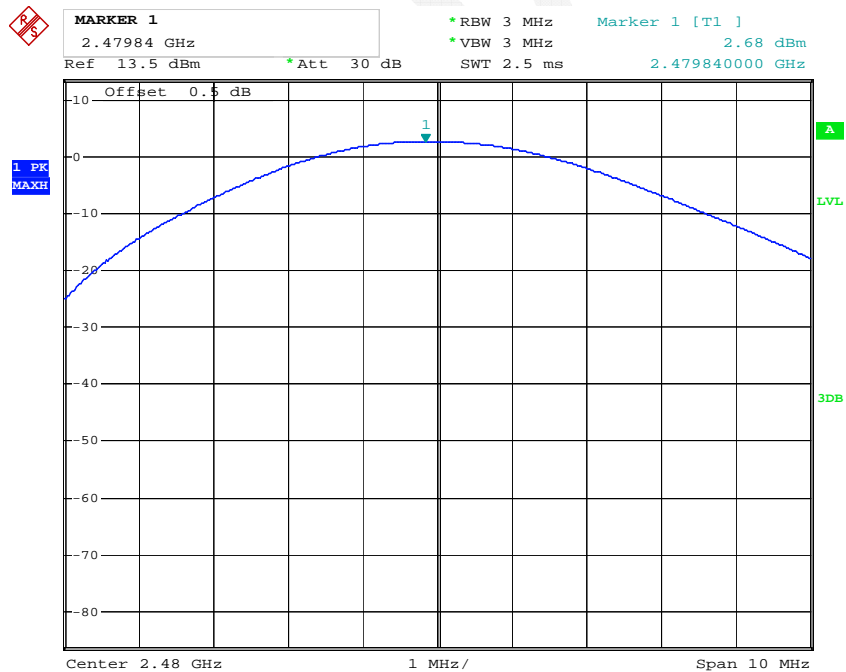
Date: 29.AUG.2014 18:07:41

### Output Power, Middle Channel



Date: 29.AUG.2014 17:56:34

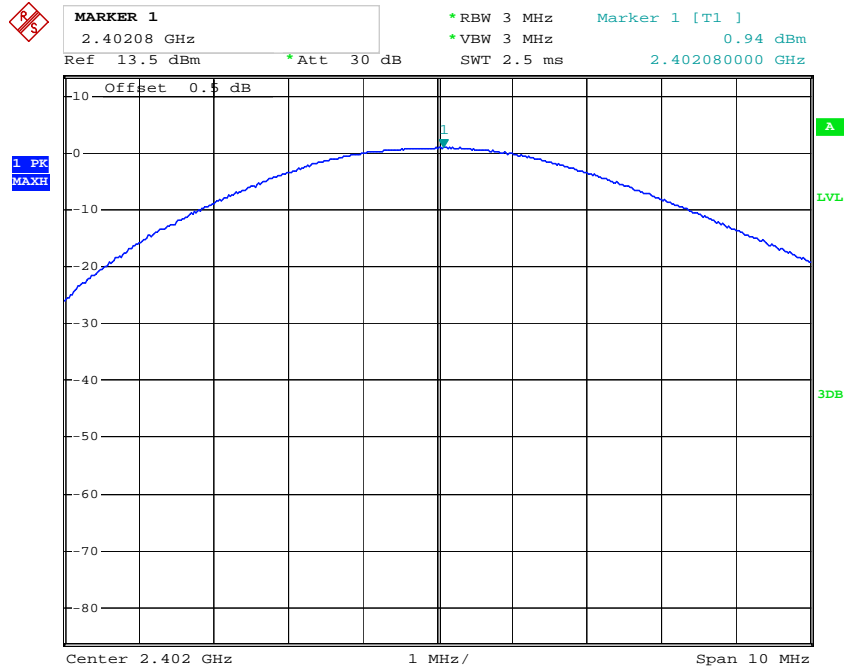
### Output Power, High Channel



Date: 29.AUG.2014 17:48:27

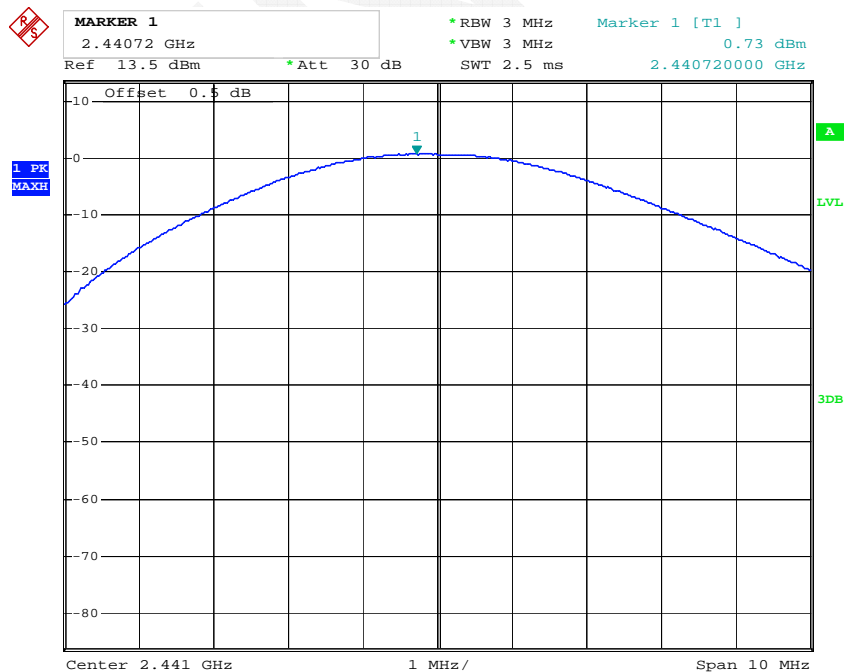
EDR Mode ( $\pi/4$ -DQPSK):

### Output Power, Low Channel



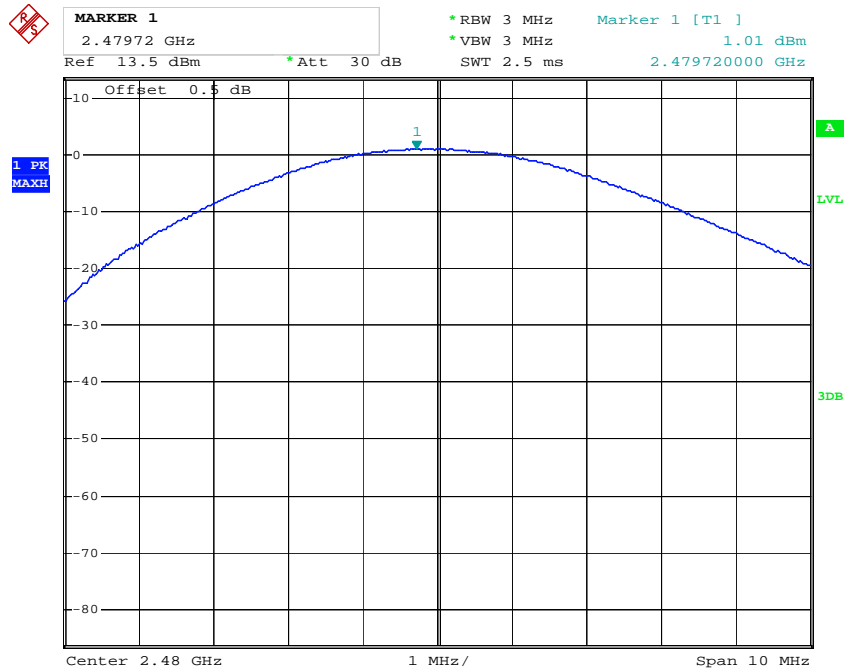
Date: 29.AUG.2014 18:08:20

### Output Power, Middle Channel



Date: 29.AUG.2014 18:12:44

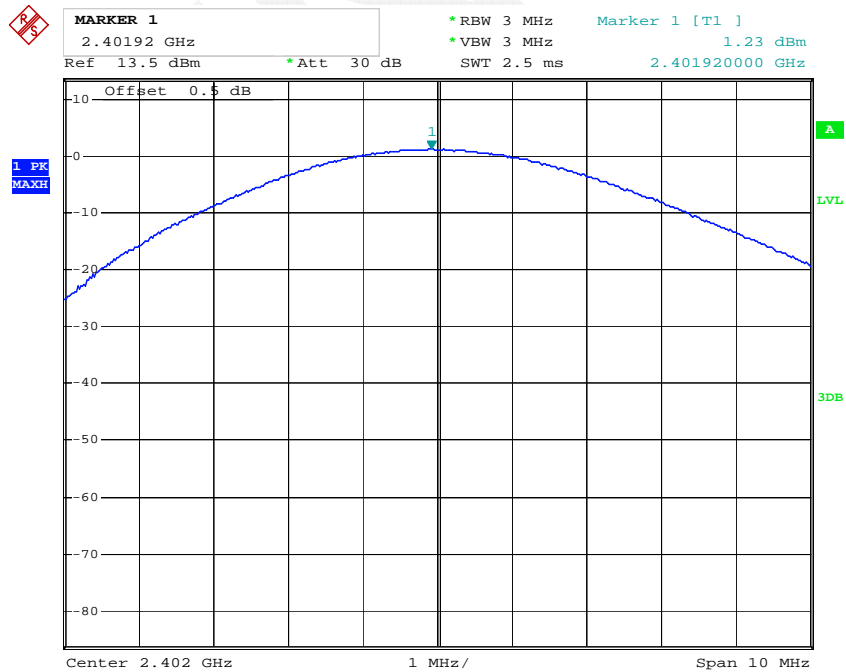
### Output Power, High Channel



Date: 29.AUG.2014 18:20:08

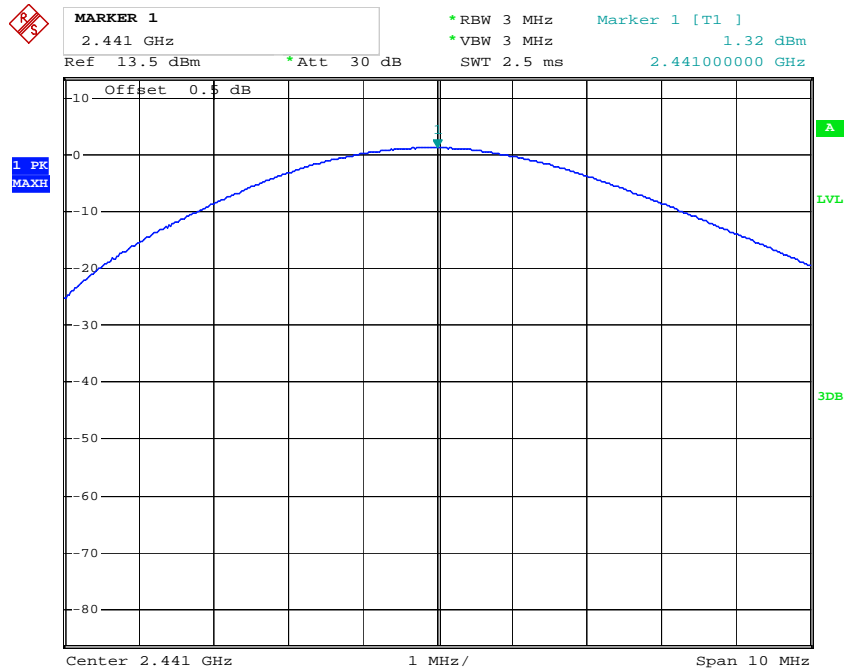
EDR Mode (8DPSK):

### Output Power, Low Channel



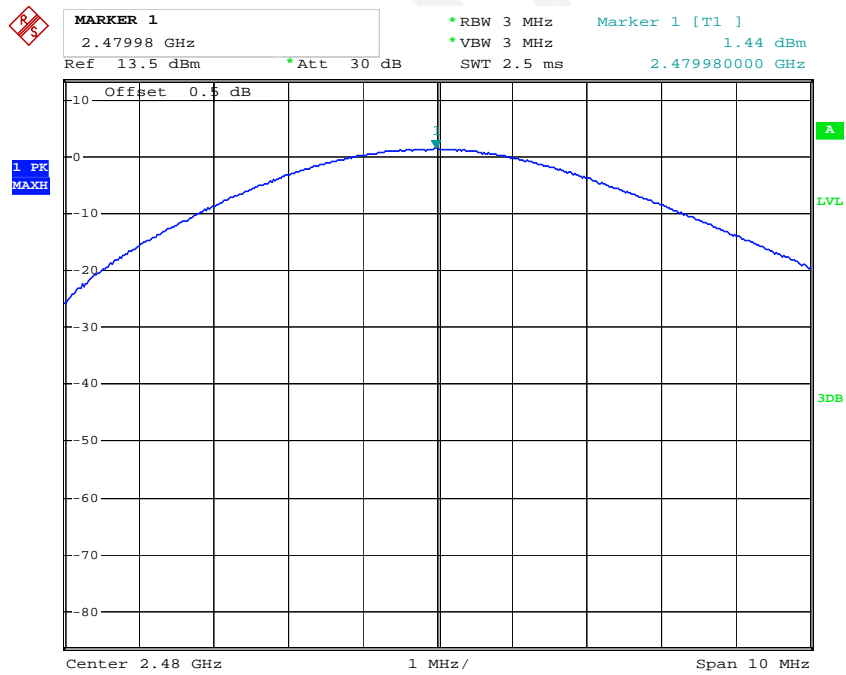
Date: 29.AUG.2014 18:31:01

### Output Power, Middle Channel



Date: 29.AUG.2014 18:25:06

### Output Power, High Channel



Date: 29.AUG.2014 18:21:00



## FCC §15.247(d) - BAND EDGES TESTING

### Applicable Standard

In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in §15.209(a) is not required. In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in §15.209(a) (see §15.205(c)).

### Test Procedure

1. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
2. Remove the antenna from the EUT and then connect to a low loss RF cable from the antenna port to a EMI test receiver, then turn on the EUT and make it operate in transmitting mode. Then set it to Low Channel and High Channel within its operating range, and make sure the instrument is operated in its linear range.
3. Set both RBW and VBW of spectrum analyzer to 100 kHz with a convenient frequency span including 100 kHz bandwidth from band edge.
4. Measure the highest amplitude appearing on spectral display and set it as a reference level. Plot the graph with marking the highest point and edge frequency.
5. Repeat above procedures until all measured frequencies were complete.

### Test Equipment List and Details

Manufacturer	Description	Model	Serial Number	Calibration Date	Calibration Due Date
R&S	Spectrum Analyzer	FSP 38	100478	2014-05-09	2015-05-08

\* **Statement of Traceability:** Bay Area Compliance Laboratories Corp. (Dongguan) attests that all calibrations have been performed, traceable to National Primary Standards and International System of Units (SI).

### Test Data

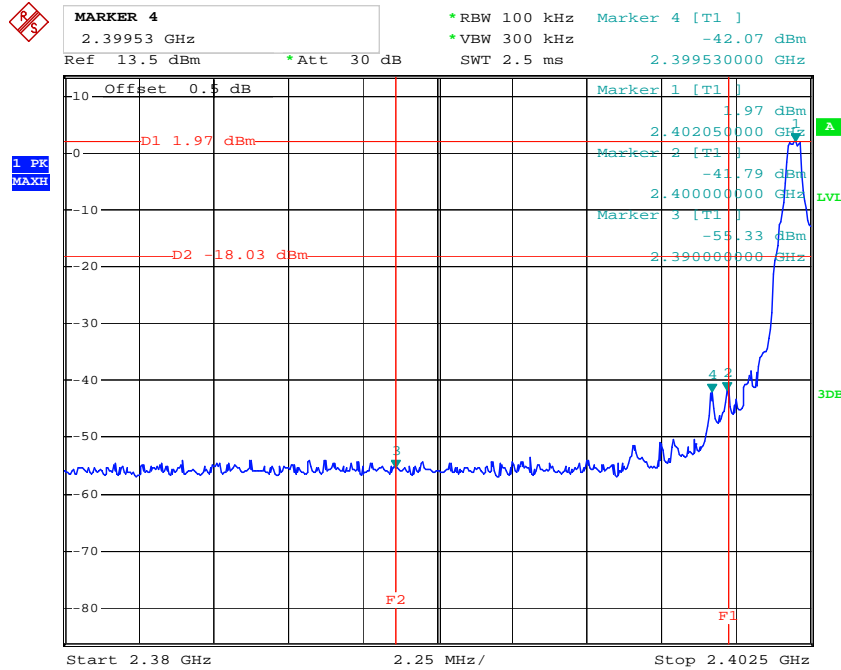
#### Environmental Conditions

Temperature:	30.1 °C
Relative Humidity:	60%
ATM Pressure:	100.8 kPa

*The testing was performed by Leon Chen on 2014-08-29.*

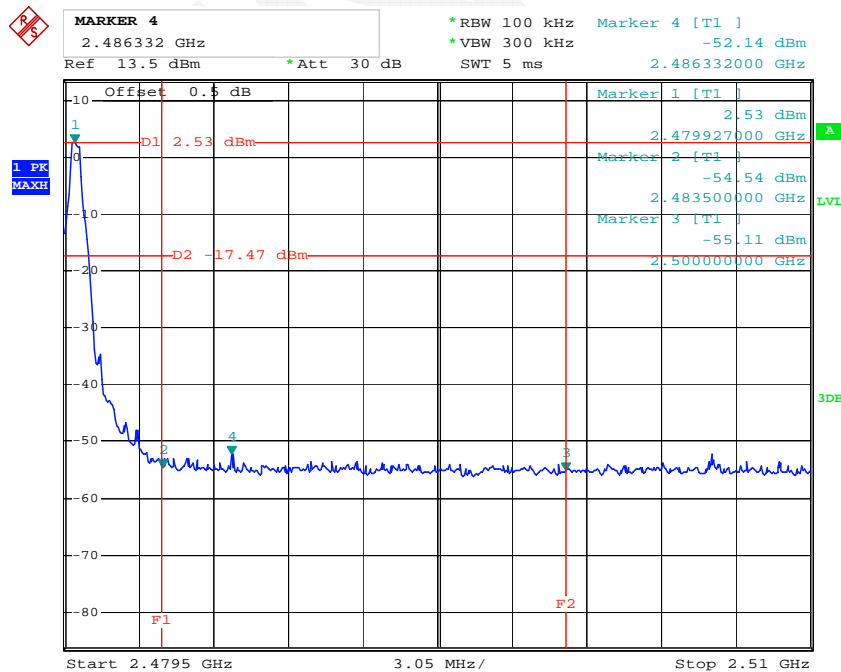
**Test Result: Compliant.**  
*BDR Mode (GFSK):*

**Band Edge, Left Side**



Date: 29.AUG.2014 18:04:29

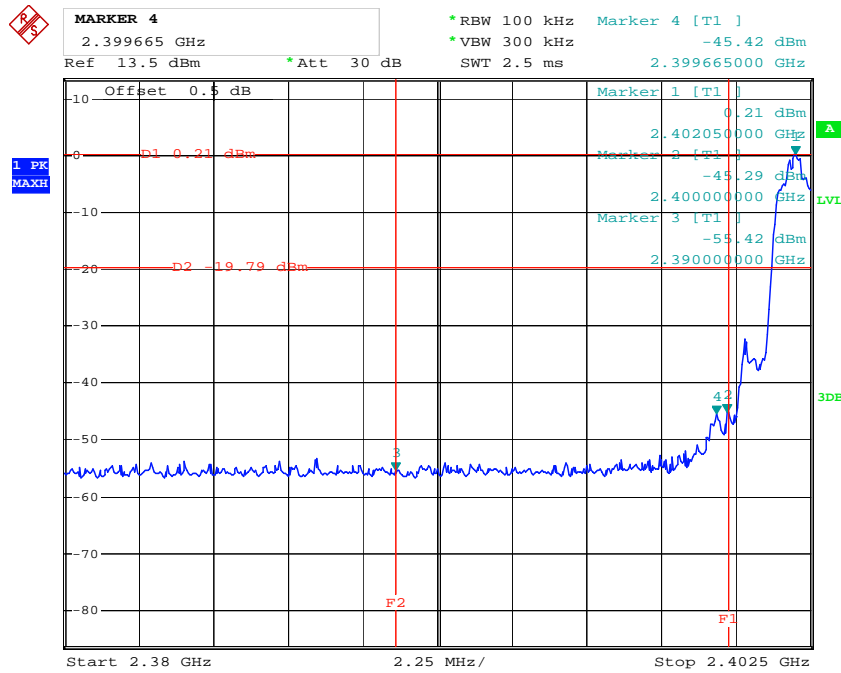
**Band Edge, Right Side**



Date: 29.AUG.2014 17:55:23

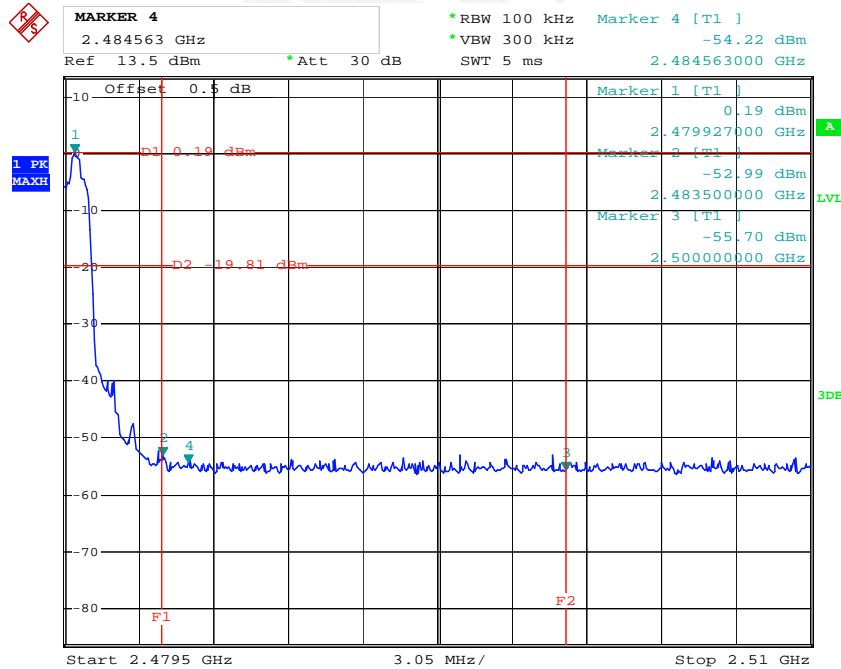
EDR Mode ( $\pi$  4-DQPSK):

**Band Edge, Left Side**



Date: 29.AUG.2014 18:11:52

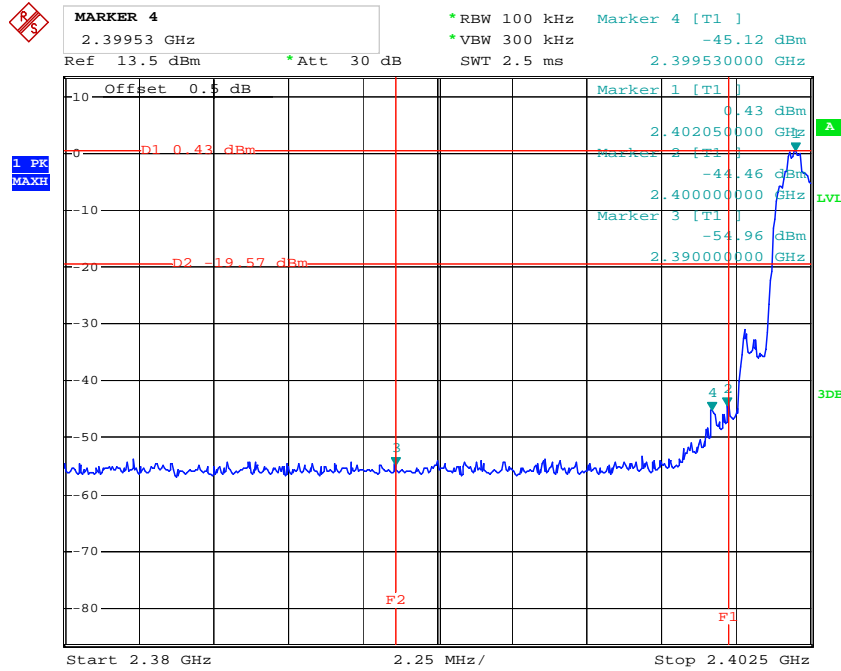
**Band Edge, Right Side**



Date: 29.AUG.2014 18:18:29

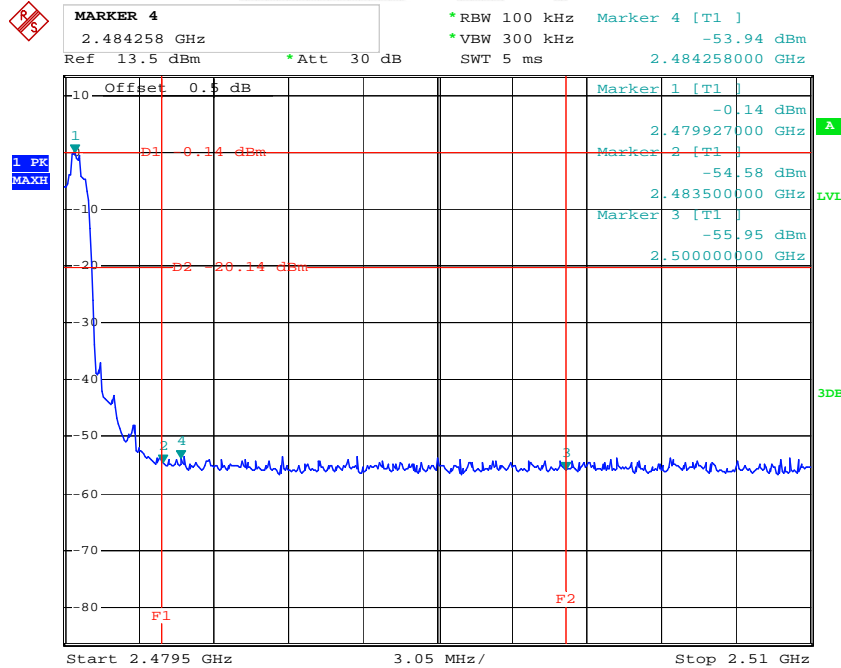
EDR Mode (8DPSK):

**Band Edge, Left Side**



Date: 29.AUG.2014 18:33:28

**Band Edge, Right Side**



Date: 29.AUG.2014 18:24:13

\*\*\*\*\* END OF REPORT \*\*\*\*\*